

# Precision Digital Power Monitor

## ISL28022

The [ISL28022](#) is a bidirectional high-side and low-side digital current sense and voltage monitor with serial interface. The device monitors current and voltage and provides the results digitally along with calculated power. The ISL28022 provides tight accuracy of less than 0.3% for both voltage and current monitoring over the entire input range. The digital power monitor has configurable fault thresholds and measurable ADC gain ranges.

The ISL28022 handles common-mode input voltage ranging from 0V to 60V. The wide range permits the device to handle telecom, automotive and industrial applications with minimal external circuitry. Both high- and low-side ground sensing applications are easily handled with the flexible architecture.

The ISL28022 consumes an average current of just 700µA and is available in a 10 Ld MSOP package. The ISL28022 is also offered in a space saving 16 Ld QFN package. The part operates across the extended temperature range from -40° C to +125° C.

### Related Literature

- [AN1955](#), “Design Ideas for Intersil Digital Power Monitors”
- [AN1875](#), “ISL28022 Digital Power Monitor Evaluation Kit (ISL28022EVKIT1Z)”
- [AN1811](#), “ISL28022 Digital Power Monitor 8 Site Evaluation Kit”

### Features

- Bus voltage sense range . . . . . 0V to 60V
- 16-bit  $\Sigma\Delta$ ADC monitors current and voltage
- Voltage measuring error . . . . . <0.3%
- Current measuring error . . . . . <0.3%
- Handles negative system voltage
- Overvoltage/undervoltage and current fault monitoring
- I<sup>2</sup>C/SMBus interface
- Wide V<sub>CC</sub> range . . . . . 3V to 5.5V
- ESD (HBM). . . . . 8kV
- Supports high speed I<sup>2</sup>C . . . . . 3.4MHz

### Applications

- Routers and servers
- DC/DC, AC/DC converters
- Battery management/charging
- Automotive power
- Power distribution
- Medical and test equipment

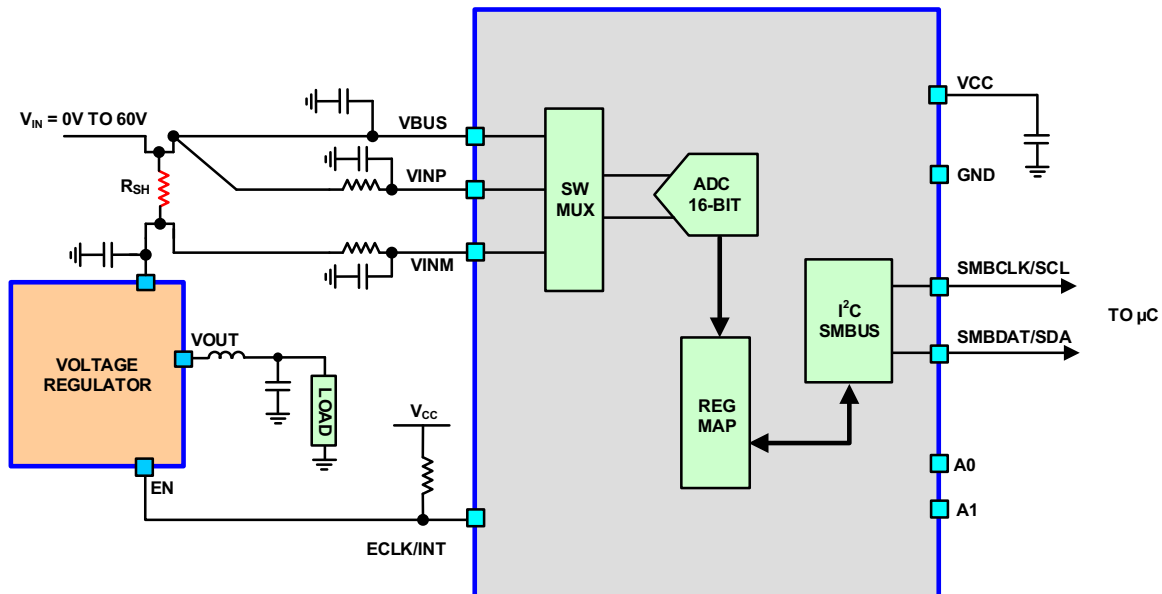


FIGURE 1. TYPICAL APPLICATION

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## Block Diagram

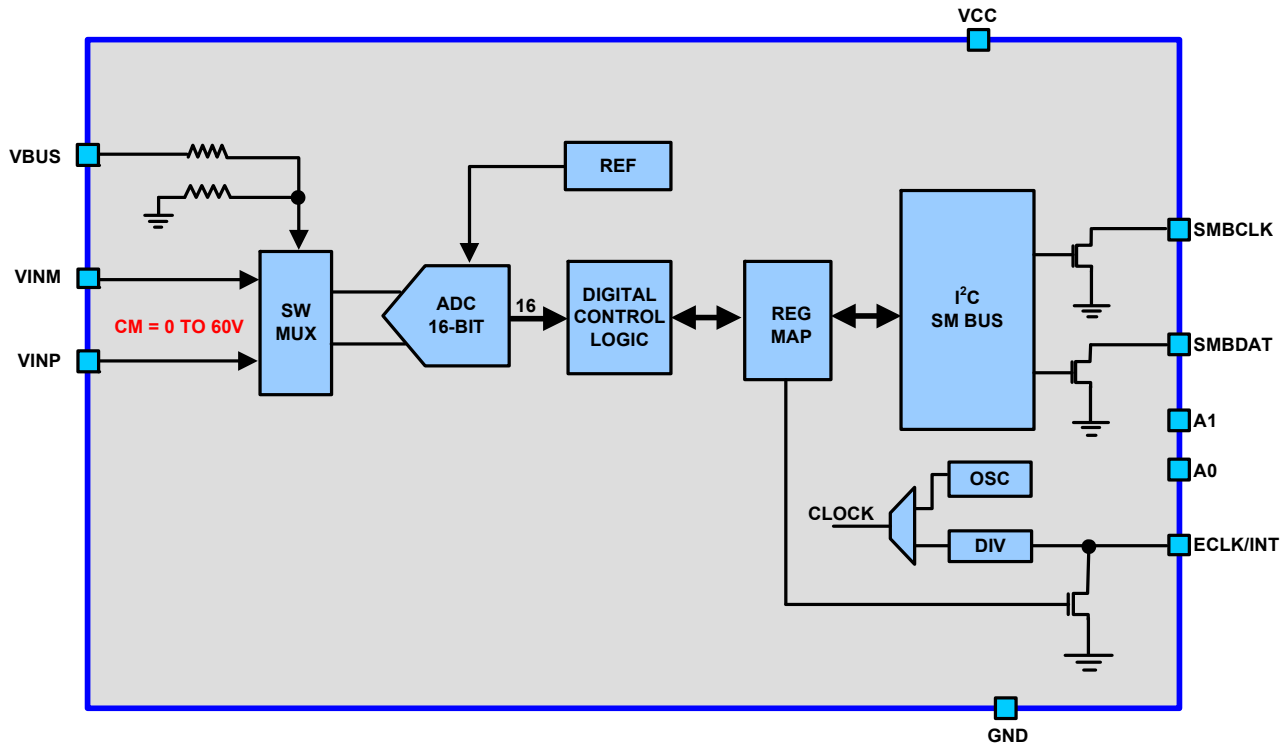


FIGURE 2. BLOCK DIAGRAM

## Ordering Information

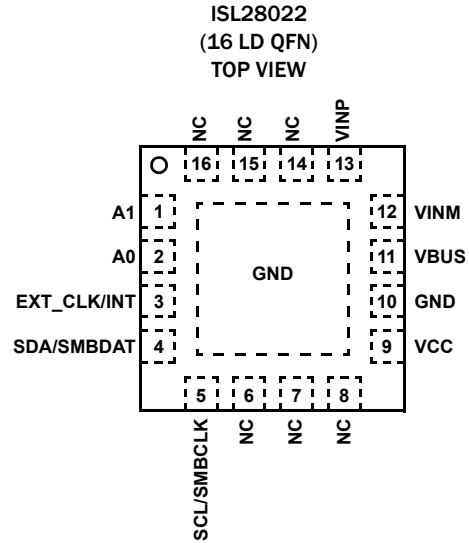
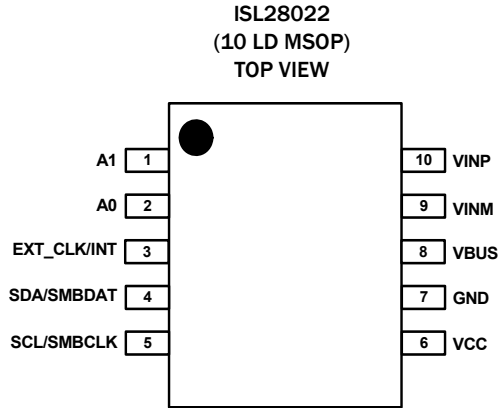
| PART NUMBER<br>(Notes 1, 2, 3) | PART MARKING   | TEMP RANGE<br>(°C) | PACKAGE<br>(RoHS Compliant) | PKG.<br>DWG. # |
|--------------------------------|--|--------------------|-----------------------------|----------------|
| ISL28022FUZ                    | 8022F  | -40 to +125        | 10 Ld MSOP                  | M10.118        |
| ISL28022FRZ                    | 022F   | -40 to +125        | 16 Ld QFN                   | L16.3x3B       |
| ISL28022EVKIT1Z                | ISL28022 Evaluation Kit (Includes Dongle Board, Generic Evaluation Board, R <sub>LOAD</sub> Board) |                    |                             |                |
| ISL28022MBEV1Z                 | ISL28022 Generic Evaluation Board  |                    |                             |                |
| ISL28022EV1Z                   | ISL28022 8-site Evaluation Board   |                    |                             |                |

### NOTES:

1. Add "-T" suffix for QFN 6k or MSOP 2.5k units tape and reel options. Add "-T7A" suffix for 250 units tape and reel options. Please refer to [TB347](#) for details on reel specifications.
2. These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.
3. For Moisture Sensitivity Level (MSL), please see device information page for [ISL28022](#). For more information on MSL please see tech brief [TB363](#).

# ISL28022

## Pin Configurations



## Pin Descriptions

| MSOP PIN NUMBER | QFN PIN NUMBER      | PIN NAME    | DESCRIPTION   |
|-----------------|---------------------|-------------|---|
| 1               | 1                   | A1          | I <sup>2</sup> C address, Bit 1   |
| 2               | 2                   | A0          | I <sup>2</sup> C address, Bit 0   |
| 3               | 3                   | EXT_CLK/INT | External ADC clock input or CPU interrupt output signal. When the pin is configured as an interrupt, the output is an open drain. |
| 4               | 4                   | SDA/SMBDAT  | I <sup>2</sup> C serial data input/output.  |
| 5               | 5                   | SCL/SMBCLK  | I <sup>2</sup> C clock input  |
| 6               | 9                   | VCC         | Positive power pin. The positive power supply to the part.  |
| 7               | 10                  | GND         | Negative power pin. Can be connected to ground or a negative voltage.   |
| 8               | 11                  | VBUS        | VBUS power voltage sense.   |
| 9               | 12                  | VINM        | Current sense minus input.  |
| 10              | 13                  | VINP        | Current sense plus input.   |
|                 | 6, 7, 8, 14, 15, 16 | NC          | No connect. No internal connection.   |
|                 | Epad                | GND         | Negative power pin. Can be connected to ground or a negative voltage.   |

# ISL28022

TABLE 1. DPM PORTFOLIO COMPARISON - ISL28022 vs ISL28023 vs ISL28025

| DESCRIPTION                                  |                          | BASIC DIGITAL POWER MONITOR | FULL FEATURE DIGITAL POWER MONITOR   | DIGITAL POWER MONITOR IN TINY PACKAGE |
|--|--------------------------|-----------------------------|--------------------------------------|---------------------------------------|
| PART NUMBER                                  |                          | ISL28022                    | ISL28023                             | ISL28025                              |
| PACKAGE                                      |                          | MSOP10, QFN16               | QFN24                                | WLCSP-16                              |
| Temperature Range                            |                          | -40 °C to +125 °C           | -40 °C to +125 °C                    | -40 °C to +125 °C                     |
| 0V to 60V Input Range                        |                          | 0V to 60V                   | Opt 1: 0V to 60V<br>Opt 2: 0V to 16V | Opt 1: 0V to 60V<br>Opt 2: 0V to 16V  |
| ADC  |                          | 16-bit                      | 16-bit                               | 16-bit                                |
| +25 °C Gain Error                            |                          | 0.30%                       | 0.25%                                | 0.25%                                 |
| Current Measure LSB Step                     |                          | 10µV                        | 2.5µV                                | 2.5µV                                 |
| +25 °C Offset                                |                          | 75µV                        | 30µV                                 | 30µV                                  |
| Primary                                      | Differential Shunt Input | X                           | X                                    | X                                     |
| Channel                                      | Independent Bus Voltage  | X                           | X                                    | X                                     |
| LV Aux                                       | Differential Shunt Input |                             | X                                    |                                       |
| Channel                                      | Independent Bus Voltage  |                             | X                                    | X                                     |
| VBus LSB Step                                | Low Voltage Bus          |                             | 0.25mV                               | 0.25mV                                |
|  | High Voltage Bus         | 4mV                         | 1mV/0.25mV                           | 1mV/0.25mV                            |
| External Temperature Sensor Input            |                          |                             | X                                    |                                       |
| HV Internal Regulator (3.3V <sub>OUT</sub> ) |                          |                             | X                                    | X                                     |
| Fast OC/OV/UV Alert Outputs                  |                          |                             | 2 Outputs                            | 2 Outputs                             |
| Margin DAC                                   |                          |                             | X                                    |                                       |
| Internal Temperature Sensor                  |                          |                             | X                                    | X                                     |
| User Select Conversion Mode/Sample Rate      |                          | X                           | X                                    | X                                     |
| Peak Min/Max Current Registers               |                          |                             | X                                    | X                                     |
| Slave Address Locations                      |                          | 16 Addresses                | 55 Addresses                         | 55 Addresses                          |
| I <sup>2</sup> C Level Translators           |                          |                             | X                                    | X                                     |
| PMBus  |                          |                             | X                                    | X                                     |
| I <sup>2</sup> C/SMBus                       |                          | X                           | X                                    | X                                     |
| High Speed (3.4MHz) I <sup>2</sup> C Mode    |                          | X                           | X                                    | X                                     |
| External Clock Input                         |                          | X                           | X                                    | X                                     |
| Power Shutdown Mode                          |                          | X                           | X                                    | X                                     |

# ISL28022

## Absolute Maximum Ratings

|   |                            |
|---|----------------------------|
| VCC   | 6.0V                       |
| VBUS Voltage                                  | 63V                        |
| Common-Mode Input Voltage (VINP, VINM)        | 63V                        |
| Differential Input Voltage (VINP, VINM)       | ±63V                       |
| Input Voltage (Digital Pins)                  | (GND - 0.3V) to 5.5V       |
| Output Voltage (Digital Pins)                 | (GND - 0.3V) to VCC + 0.3V |
| Open-Drain Output Current                     | 10mA                       |
| Open-Drain Voltage (Interrupt)                | 24V                        |
| ESD Rating                                    |                            |
| Human Body Model (Tested per JESD22-A114)     | 8kV                        |
| Machine Model (Tested per JESD22-A115)        | 400V                       |
| Charged Device Model (Tested per JESD22-C101) | 2kV                        |
| Latch-Up (Tested per JESD-78B)                | 60V at +125°C              |

## Thermal Information

|   |                           |                      |
|---|---------------------------|----------------------|
| Thermal Resistance (Typical)                      | $\theta_{JA}$ (°C/W)      | $\theta_{JC}$ (°C/W) |
| 16 Ld QFN (Notes 4, 5)                            | 52                        | 6.5                  |
| 10 Ld MSOP (Notes 6, 7)                           | 150                       | 55                   |
| Maximum Storage Temperature Range                 | -65°C to +150°C           |                      |
| Maximum Junction Temperature (T <sub>JMAX</sub> ) | +150°C                    |                      |
| Pb-Free Reflow Profile                            | see <a href="#">TB493</a> |                      |

## Recommended Operating Conditions

|   |                 |
|---|-----------------|
| Ambient Temperature Range (T <sub>A</sub> ) | -40°C to +125°C |
|---|-----------------|

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

### NOTES:

- $\theta_{JA}$  is measured in free air with the component mounted on a high effective thermal conductivity test board with “direct attach” features. See Tech Brief [TB379](#).
- For  $\theta_{JC}$ , the “case temp” location is the center of the exposed metal pad on the package underside.
- $\theta_{JA}$  is measured with the component mounted on a high effective thermal conductivity test board in free air. See Tech Brief [TB379](#) for details.
- For  $\theta_{JC}$ , the “case temp” location is taken at the package top center.

**Electrical Specifications** T<sub>A</sub> = +25°C, V<sub>CC</sub> = 3.3, V<sub>INP</sub> = V<sub>BUS</sub> = 12V, V<sub>SENSE</sub> = V<sub>INP</sub>-V<sub>VINM</sub> = 32mV, unless otherwise specified. All voltages with respect to GND pin.

| PARAMETER               | DESCRIPTION  | TEST CONDITIONS                                  | MIN<br>(Note 8) | TYP  | MAX<br>(Note 8) | UNIT  |
|-------------------------|--|--|-----------------|------|-----------------|-------|
| <b>INPUTS</b>           |  |  |                 |      |                 |       |
| V <sub>SENSEDIFF</sub>  | Useful Full-Scale Current Sense Differential Voltage Range (VINP-VINM) | PGA gain = /1                                    | 0               |      | ±40             | mV    |
|                         |  | PGA gain = /2                                    | 0               |      | ±80             | mV    |
|                         |  | PGA gain = /4                                    | 0               |      | ±160            | mV    |
|                         |  | PGA gain = /8                                    | 0               |      | ±320            | mV    |
| V <sub>SHUNT_step</sub> | LSB Step Size, Shunt Voltage   |  |                 | 10   |                 | µV    |
| V <sub>CMSENSE</sub>    | Current Sense Common-Mode (VINP, VINM)                                 |  | 0               |      | 60              | V     |
| V <sub>OS</sub>         | V <sub>SENSE</sub> Offset Voltage                                      | PGA gain = /1, /2, /4, /8;<br>ADC setting = 1111 |                 | ±10  | ±75             | µV    |
| V <sub>OSTC</sub>       | V <sub>SENSE</sub> Offset Voltage Temperature Coefficient              |  |                 | 0.15 |                 | µV/°C |
| CMRR                    | V <sub>SENSE</sub> V <sub>OS</sub> vs Common-Mode                      | V <sub>BUS</sub> = 0V to 60V; BRNG = 2, 3        | 110             | 130  |                 | dB    |
| PSRR                    | V <sub>SENSE</sub> V <sub>OS</sub> vs Power Supply                     | V <sub>CC</sub> = 3V to 5V                       |                 | 105  |                 | dB    |
| A <sub>CS</sub>         | Current Sense Gain Error   |  |                 | ±40  |                 | m%    |
| A <sub>CS</sub> TC      | Current Sense Gain Error Temperature Coefficient                       |  |                 | ±1   |                 | m%/°C |
| I <sub>VINACT</sub>     | Input Leakage, VIN Pins  | Active mode<br>(for both VINP and VINM pins)     |                 | ±20  |                 | µA    |
| I <sub>VINACT</sub>     | Input Leakage, VIN Pins  | Power-down mode<br>(for both VINP and VINM pins) |                 | ±0.1 | ±0.5            | µA    |
| V <sub>BUS</sub>        | Useful Bus Voltage Range   | BRNG = 0   | 0               |      | 16              | V     |
|                         |  | BRNG = 1   | 0               |      | 32              | V     |
|                         |  | BRNG = 2, 3                                      | 0               |      | 60              | V     |
| V <sub>BUS_Step</sub>   | LSB Step Size, Bus Voltage   | BRNG = 0   |                 | 4    |                 | mV    |
| V <sub>BUS_VCO</sub>    | V <sub>BUS</sub> Voltage Coefficient                                   |  |                 | 50   |                 | ppm/V |
| R <sub>VBACT</sub>      | Input Impedance, VBUS Pin  | Active mode                                      |                 | 600  |                 | kΩ    |

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**Electrical Specifications**  $T_A = +25^\circ\text{C}$ ,  $V_{CC} = 3.3$ ,  $V_{INP} = V_{BUS} = 12\text{V}$ ,  $V_{SENSE} = V_{INP} - V_{INM} = 32\text{mV}$ , unless otherwise specified. All voltages with respect to GND pin. (Continued)

| PARAMETER                                      | DESCRIPTION  | TEST CONDITIONS   | MIN<br>(Note 8)     | TYP                  | MAX<br>(Note 8)     | UNIT          |
|--|--|---|---------------------|----------------------|---------------------|---------------|
| <b>DC ACCURACY</b>                             |  |   |                     |                      |                     |               |
|  | ADC Resolution (Native)  | PGA gain = /1, $V_{SENSE} = \pm 320\text{mV}$   |                     | 16                   |                     | Bits          |
|  | Current Measurement Error  | $T_A = +25^\circ\text{C}$   |                     | $\pm 0.2$            | $\pm 0.3$           | %             |
|  | Current Measurement Error Over-Temperature                       | $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$  |                     |                      | $\pm 0.5$           | %             |
|  |  | $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$   |                     |                      | $\pm 1$             | %             |
|  | Bus Voltage Measurement Error                                    | $T_A = +25^\circ\text{C}$   |                     | $\pm 0.2$            | $\pm 0.3$           | %             |
|  | Bus Voltage Measurement Error Over-Temperature                   | $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$  |                     |                      | $\pm 0.5$           | %             |
|  |  | $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$   |                     |                      | $\pm 1$             | %             |
| <b>ADC TIMING SPECS</b>                        |  |   |                     |                      |                     |               |
| $t_s$  | ADC Conversion Time<br>Mode = 5 or 6                             | ADC setting = 0000  |                     | 72.0                 | 79.2                | $\mu\text{s}$ |
|  |  | ADC setting = 0001  |                     | 132.0                | 145.2               | $\mu\text{s}$ |
|  |  | ADC setting = 0010  |                     | 258.0                | 283.8               | $\mu\text{s}$ |
|  |  | ADC setting = 0011  |                     | 508.0                | 558.8               | $\mu\text{s}$ |
|  |  | ADC setting = 1001  |                     | 1.01                 | 1.11                | ms            |
|  |  | ADC setting = 1010  |                     | 2.01                 | 2.21                | ms            |
|  |  | ADC setting = 1011  |                     | 4.01                 | 4.41                | ms            |
|  |  | ADC setting = 1100  |                     | 8.01                 | 8.81                | ms            |
|  |  | ADC setting = 1101  |                     | 16.01                | 17.61               | ms            |
|  |  | ADC setting = 1110  |                     | 32.01                | 35.21               | ms            |
| ADC setting = 1111                             |  | 64.01   | 70.41               | ms                   |                     |               |
| <b>I<sup>2</sup>C INTERFACE SPECIFICATIONS</b> |  |   |                     |                      |                     |               |
| $V_{IL}$                                       | SDA and SCL Input Buffer LOW Voltage                             |   | -0.3                |                      | $0.3 \times V_{CC}$ | V             |
| $V_{IH}$                                       | SDA and SCL Input Buffer HIGH Voltage                            |   | $0.7 \times V_{CC}$ |                      | $V_{CC} + 0.3$      | V             |
| Hysteresis                                     | SDA and SCL Input Buffer Hysteresis                              |   |                     | $0.05 \times V_{CC}$ |                     | V             |
| $V_{OL}$                                       | SDA Output Buffer LOW Voltage, Sinking 3mA                       | $V_{CC} = 5\text{V}$ , $I_{OL} = 3\text{mA}$  | 0                   | 0.02                 | 0.40                | V             |
| $C_{PIN}$                                      | SDA and SCL Pin Capacitance                                      | $T_A = +25^\circ\text{C}$ , $f = 1\text{MHz}$ ,<br>$V_{CC} = 5\text{V}$ , $V_{IN} = 0\text{V}$ ,<br>$V_{OUT} = 0\text{V}$   |                     |                      | 10                  | pF            |
| $f_{SCL}$                                      | SCL Frequency  |   |                     |                      | 400                 | kHz           |
| $t_{IN}$                                       | Pulse Width Suppression Time at SDA and SCL Inputs               | Any pulse narrower than the maximum spec is suppressed  |                     |                      | 50                  | ns            |
| $t_{AA}$                                       | SCL Falling Edge to SDA Output Data Valid                        | SCL falling edge crossing 30% of $V_{CC}$ , until SDA exits the 30% to 70% of $V_{CC}$ window.                              |                     |                      | 900                 | ns            |
| $t_{BUF}$                                      | Time the Bus Must be Free Before the Start of a New Transmission | SDA crossing 70% of $V_{CC}$ during a STOP condition, to SDA crossing 70% of $V_{CC}$ during the following START condition. | 1300                |                      |                     | ns            |
| $t_{LOW}$                                      | Clock LOW Time   | Measured at the 30% of $V_{CC}$ crossing  | 1300                |                      |                     | ns            |
| $t_{HIGH}$                                     | Clock HIGH Time  | Measured at the 70% of $V_{CC}$ crossing  | 600                 |                      |                     | ns            |
| $t_{SU:STA}$                                   | START Condition Setup Time                                       | SCL rising edge to SDA falling edge<br>Both crossing 70% of $V_{CC}$  | 600                 |                      |                     | ns            |
| $t_{HD:STA}$                                   | START Condition Hold Time  | From SDA falling edge crossing 30% of $V_{CC}$ to SCL falling edge crossing 70% of $V_{CC}$                                 | 600                 |                      |                     | ns            |

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**Electrical Specifications**  $T_A = +25^\circ\text{C}$ ,  $V_{CC} = 3.3$ ,  $V_{INP} = V_{BUS} = 12\text{V}$ ,  $V_{SENSE} = V_{INP} - V_{INM} = 32\text{mV}$ , unless otherwise specified. All voltages with respect to GND pin. (Continued)

| PARAMETER           | DESCRIPTION   | TEST CONDITIONS   | MIN<br>(Note 8)       | TYP | MAX<br>(Note 8) | UNIT          |
|---------------------|---|---|-----------------------|-----|-----------------|---------------|
| $t_{SU:DAT}$        | Input Data Setup Time                                 | From SDA exiting the 30% to 70% of $V_{CC}$ window, to SCL rising edge crossing 30% of $V_{CC}$   | 100                   |     |                 | ns            |
| $t_{HD:DAT}$        | Input Data Hold Time                                  | From SCL falling edge crossing 30% of $V_{CC}$ to SDA entering the 30% to 70% of $V_{CC}$ window  | 20                    |     | 900             | ns            |
| $t_{SU:STO}$        | STOP Condition Setup Time                             | From SCL rising edge crossing 70% of $V_{CC}$ , to SDA rising edge crossing 30% of $V_{CC}$   | 600                   |     |                 | ns            |
| $t_{HD:STO}$        | STOP Condition Hold Time                              | From SDA rising edge to SCL falling edge. Both crossing 70% of $V_{CC}$ .   | 600                   |     |                 | ns            |
| $t_{DH}$            | Output Data Hold Time                                 | From SCL falling edge crossing 30% of $V_{CC}$ , until SDA enters the 30% to 70% of $V_{CC}$ window   | 0                     |     |                 | ns            |
| $t_R$               | SDA and SCL Rise Time                                 | From 30% to 70% of $V_{CC}$   | $20 + 0.1 \times C_b$ |     | 300             | ns            |
| $t_F$               | SDA and SCL Fall Time                                 | From 70% to 30% of $V_{CC}$   | $20 + 0.1 \times C_b$ |     | 300             | ns            |
| $C_b$               | Capacitive Loading of SDA or SCL                      | Total on-chip and off-chip  |                       | 75  |                 | pF            |
| $R_{PU}$            | SDA and SCL Bus Pull-Up Resistor Off-Chip             | Maximum is determined by $t_R$ and $t_F$<br>For $C_b = 400\text{pF}$ , maximum is about $2\text{k}\Omega$ – $2.5\text{k}\Omega$<br>For $C_b = 40\text{pF}$ , maximum is about $15\text{k}\Omega$ – $20\text{k}\Omega$ | 1                     |     |                 | k             |
| <b>POWER SUPPLY</b> |   |   |                       |     |                 |               |
|                     | Operating Supply Voltage Range                        |   | 3                     |     | 5.5             | V             |
| $I_{CCEXT}$         | Power Supply Current On $V_{CC}$ Pin, Active Mode     | External power supply mode, $V_{CC} = 5\text{V}$  |                       | 0.7 | 1.0             | mA            |
| $I_{CCPD}$          | Power Supply Current On $V_{CC}$ Pin, Power-Down Mode | External power supply mode, $V_{CC} = 5\text{V}$  |                       | 5   | 15              | $\mu\text{A}$ |

**NOTE:**

8. Parameters with MIN and/or MAX limits are 100% tested at  $+25^\circ\text{C}$ , unless otherwise specified. Temperature limits established by characterization and are not production tested.



## Typical Performance Curves

$T_A = +25^\circ\text{C}$ ,  $V_{CC} = 3.3\text{V}$ ,  $V_{INP} = V_{BUS} = 12\text{V}$ ,  $S(B)ADC = 15$ ;

unless otherwise specified.

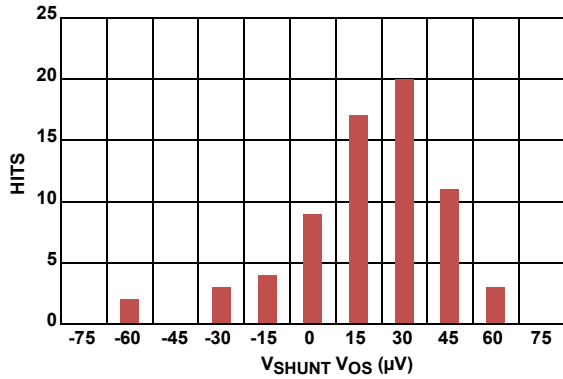


FIGURE 3.  $V_{SHUNT} V_{OS}$

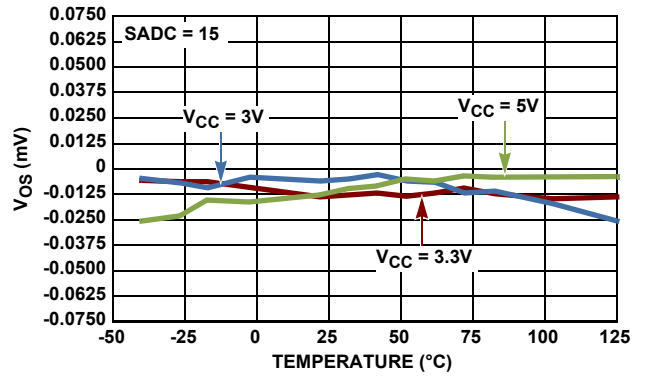


FIGURE 4.  $V_{SHUNT} V_{OS}$  vs TEMPERATURE

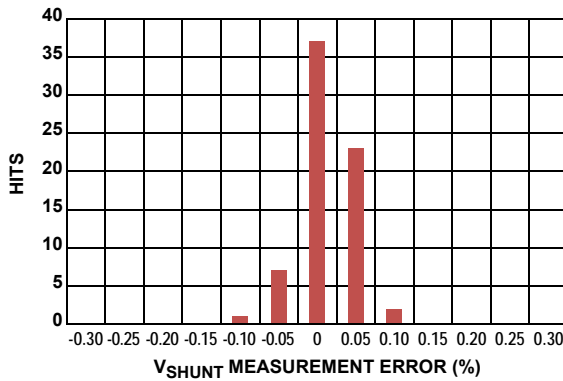


FIGURE 5.  $V_{SHUNT}$  MEASUREMENT ERROR

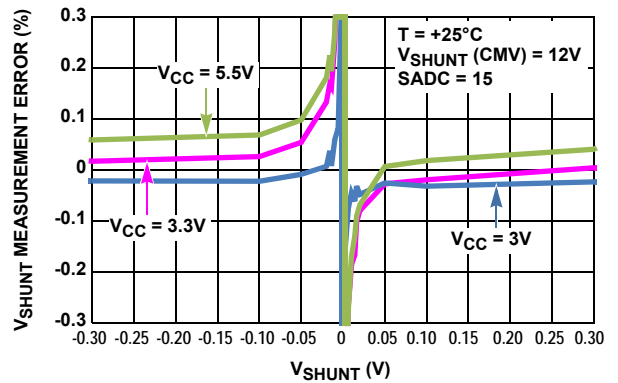


FIGURE 6.  $V_{SHUNT}$  MEASUREMENT ERROR vs  $V_{SHUNT}$  INPUT

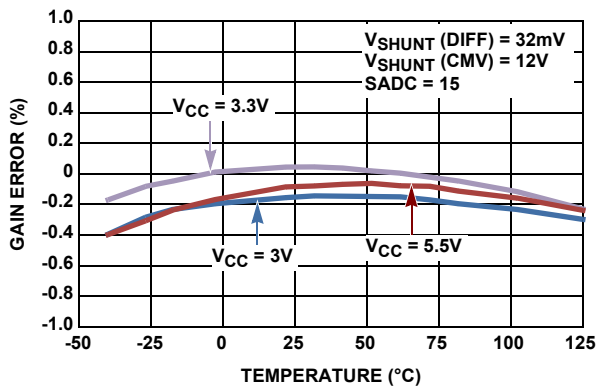


FIGURE 7.  $V_{SHUNT}$  GAIN vs TEMPERATURE

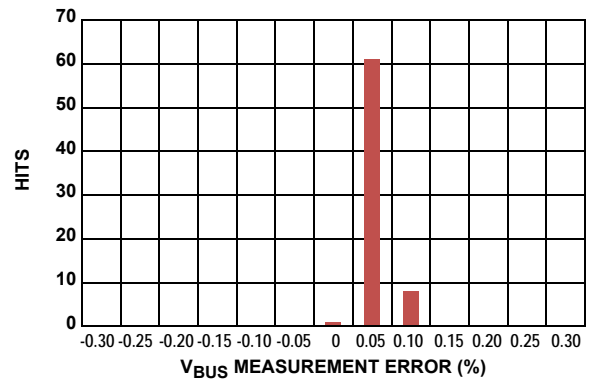


FIGURE 8.  $V_{BUS}$  MEASUREMENT ERROR DISTRIBUTION

## Typical Performance Curves

$T_A = +25^\circ\text{C}$ ,  $V_{CC} = 3.3\text{V}$ ,  $V_{INP} = V_{BUS} = 12\text{V}$ ,  $S(B)ADC = 15$ ;

unless otherwise specified. (Continued)

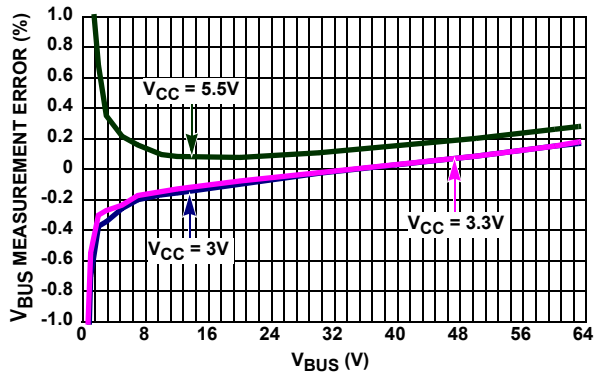


FIGURE 9.  $V_{BUS}$  MEASUREMENT ERROR vs  $V_{BUS}$  ( $T_A = +25^\circ\text{C}$ )

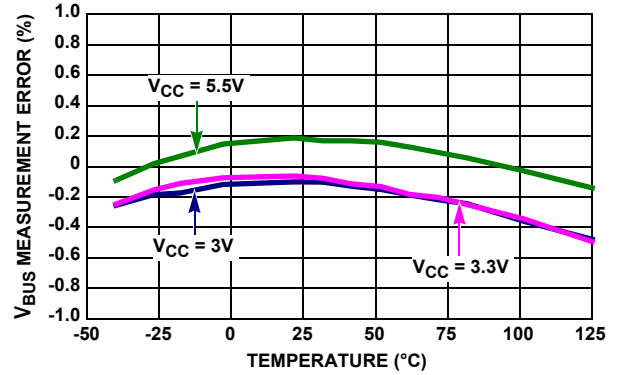


FIGURE 10.  $V_{BUS}$  MEASUREMENT ERROR vs TEMPERATURE

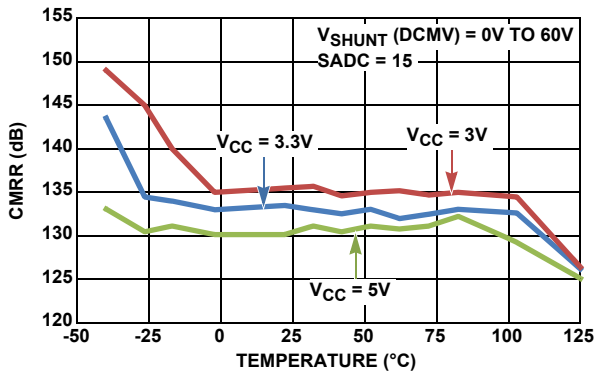


FIGURE 11. CMRR vs TEMPERATURE

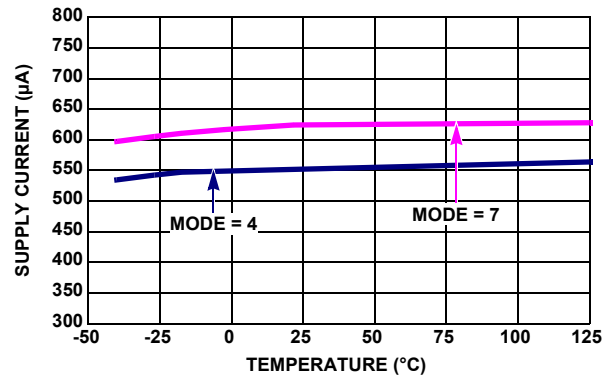


FIGURE 12. SUPPLY CURRENT vs MODE vs TEMPERATURE

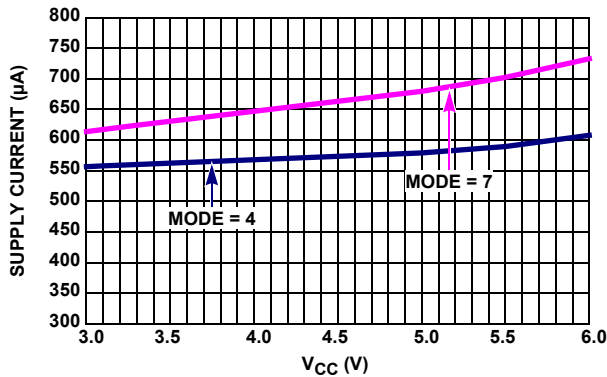


FIGURE 13. SUPPLY CURRENT vs MODE vs  $V_{CC}$

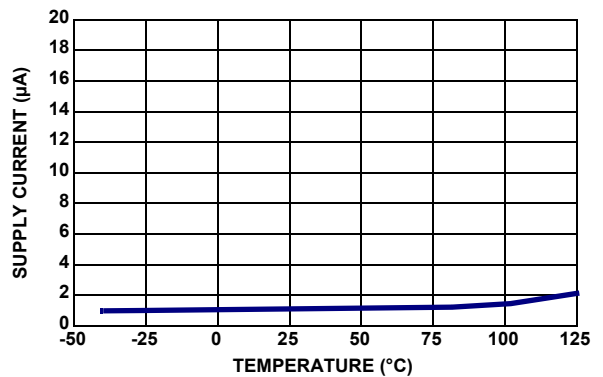


FIGURE 14. SUPPLY CURRENT vs MODE 0 vs TEMPERATURE

## Typical Performance Curves $T_A = +25^\circ\text{C}$ , $V_{CC} = 3.3\text{V}$ , $V_{INP} = V_{BUS} = 12\text{V}$ , $S(B)ADC = 15$ ; unless otherwise specified. (Continued)

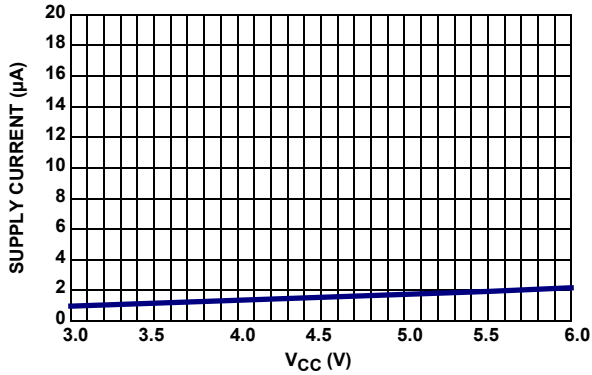


FIGURE 15. SUPPLY CURRENT vs MODE 0 vs  $V_{CC}$

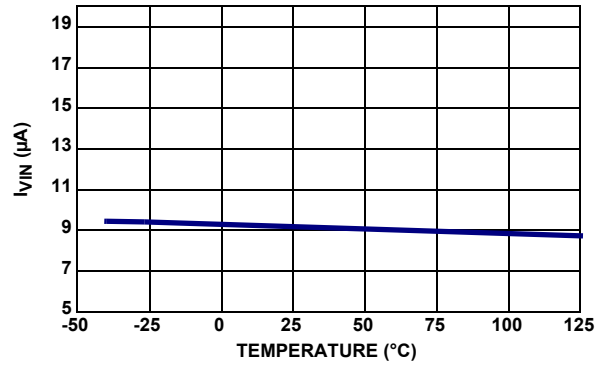


FIGURE 16. SHUNT  $I_{VIN}$  vs TEMPERATURE (MODE 5)

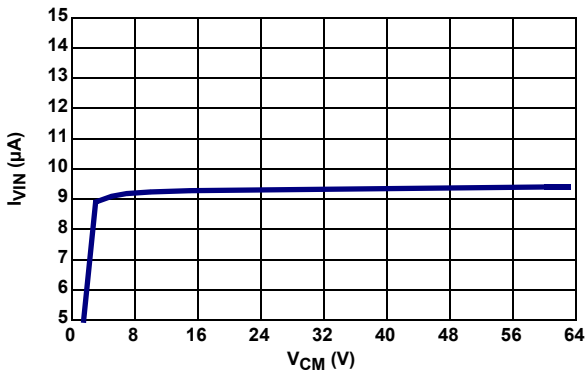


FIGURE 17. SHUNT  $I_{VIN}$  vs COMMON-MODE VOLTAGE (MODE 5)

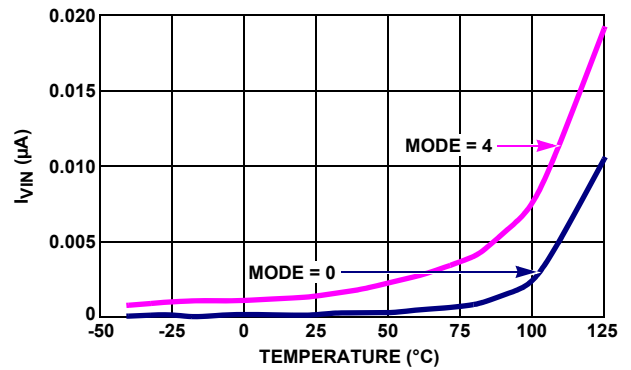


FIGURE 18. SHUNT  $I_{VIN}$  vs TEMPERATURE (MODE 0, 4)

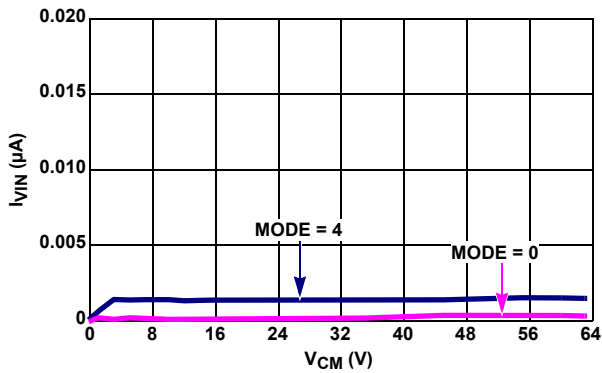


FIGURE 19. SHUNT  $I_{VIN}$  vs COMMON-MODE VOLTAGE (MODE 0, 4)

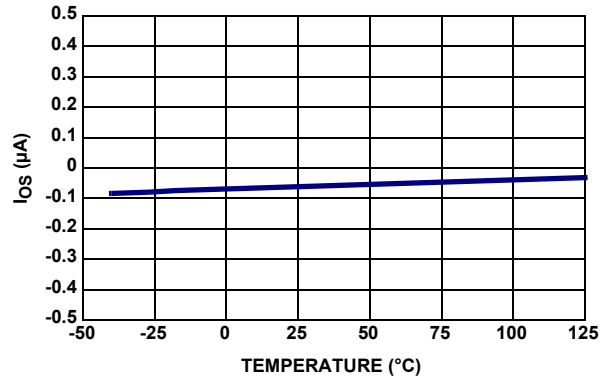


FIGURE 20. SHUNT  $I_{OS}$  vs TEMPERATURE (MODE 5)

## Typical Performance Curves $T_A = +25^\circ\text{C}$ , $V_{CC} = 3.3\text{V}$ , $V_{INP} = V_{BUS} = 12\text{V}$ , $S(B)ADC = 15$ ; unless otherwise specified. (Continued)

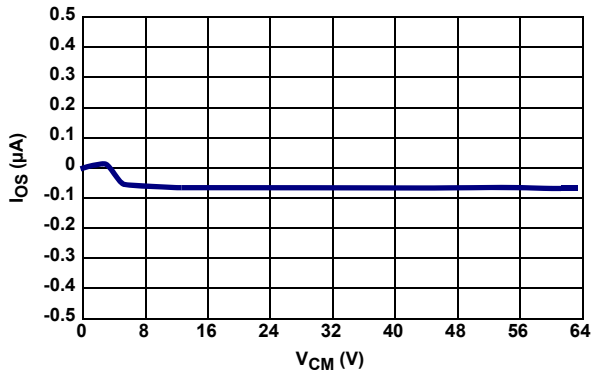


FIGURE 21. SHUNT  $I_{OS}$  vs COMMON-MODE VOLTAGE (MODE 5)

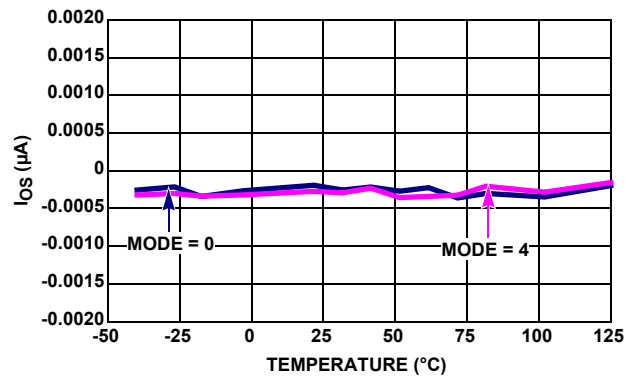


FIGURE 22. SHUNT  $I_{OS}$  vs TEMPERATURE (MODE 0, 4)

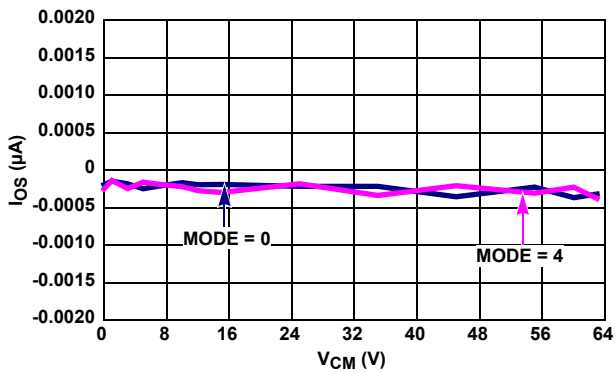


FIGURE 23. SHUNT  $I_{OS}$  vs COMMON-MODE VOLTAGE (MODE 0, 4)

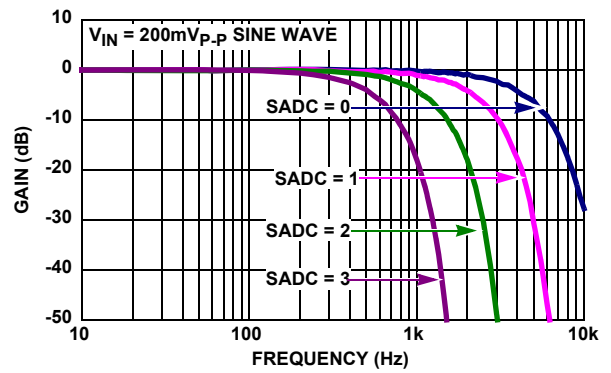


FIGURE 24.  $V_{SHUNT}$  BANDWIDTH vs SADC MODE

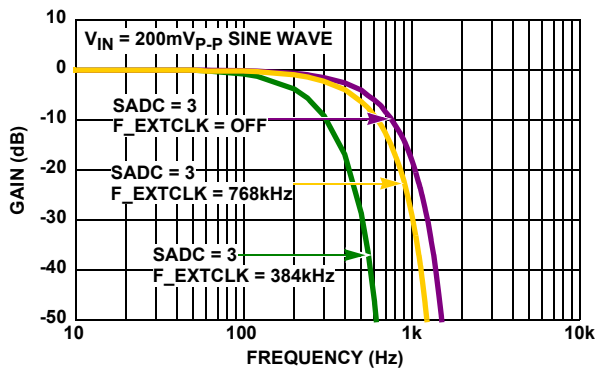


FIGURE 25.  $V_{SHUNT}$  BANDWIDTH vs EXTERNAL CLOCK FREQUENCY

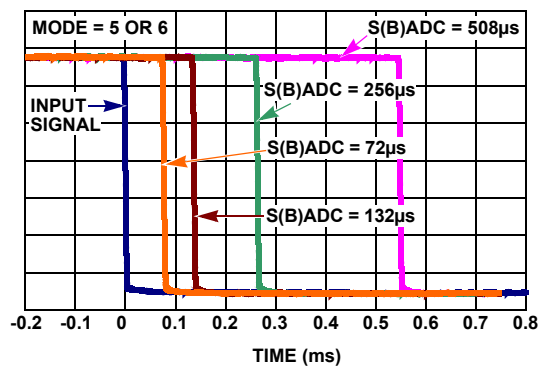


FIGURE 26. INTERRUPT TIMING

## Functional Description

### Overview

The ISL28022 is a Digital Power Monitor (DPM) device that is capable of measuring bidirectional currents while monitoring the bus voltage.

The DPM requires an external shunt resistor to enable current measurements. The shunt resistor translates the bus current to a voltage. The DPM measures the voltage across the shunt resistors and reports the measured value out digitally via an I<sup>2</sup>C interface. A register within the DPM is reserved to store the value of the shunt resistor. The stored current sense resistor value allows the DPM to output the current value to an external digital device.

The ISL28022 measures bus voltage and current sequentially. The device has a power measurement functionality that multiplies current and voltage measured values. The power calculation is stored in a unique register. The power measurement allows the user to monitor power to or from the load in addition to current and voltage.

The ISL28022 can monitor supplies from 0V to 60V while operating on a chip supply ranging from 3V to 5.5V.

The ISL28022 ADC sample rate can be configured to an internal oscillator (500kHz) or a user can provide a synchronized clock.

### Detailed Description

The ISL28022 consists of a two channel analog front end multiplexer, a 16-bit sigma delta ADC and digital signal processing/serial communication circuitry.

The main block within the device is a 3rd order Sigma Delta ADC. The input signal bandwidth is 1kHz, wide enough for power monitoring applications. The main block includes an internal 1.2V bandgap voltage reference that is used to drive the ADC.

The analog front end multiplexer selects the input to the ADC. The selection to the input of the ADC is either a single-ended V<sub>BUS</sub> measurement or a fully differential measurement across a shunt resistor.

The digital block contains controllable registers, I<sup>2</sup>C serial communication circuitry and a state machine. The state machine controls the behavior of the ADC acquisition, whether the acquisition is triggered or continuous. A more detailed description of the state machine states can be found in ["MODE: Operating Mode" on page 15](#).

### Functional Pin Descriptions

#### A1

A1 is the address select pin. A1 is one of two I<sup>2</sup>C/SMBus slave address select pins that are multilogic programmable for a total of 16 different address combinations.

There are four selectable levels for A1, VCC, GND, SCL/SMBCLK, and SDA/SMBDAT. See [Table 22](#) for more details in setting the slave address of the device.

#### A0

A0 is the address select pin. A0 is one of two I<sup>2</sup>C/SMBus slave address select pins that are multilogic programmable for a total of 16 different address combinations.

There are four selectable levels for A0, VCC, GND, SCL/SMBCLK, and SDA/SMBDAT. See [Table 22](#) for more details in setting the slave address of the device.

#### EXT\_CLK/INT

EXT\_CLK/INT is the External/Interrupt clock pin. EXT\_CLK/INT is a bidirectional pin. The pin provides a connection to the system clock. The system clock is connected to the ADC. The acquisitions rate of the ADC can be varied through the EXT\_CLK/INT pin. The pin functionality is set through a control register bit.

When the EXT\_CLK/INT pin is configured as an output, the pin functionality becomes an interrupt flag to connecting devices. EXT\_CLK/INT pin as an output requires a pull-up resistor to a power supply, up to 20V, for proper operation. The internal threshold detectors (OV<sub>sh</sub>/UV<sub>sh</sub>/OV<sub>b</sub>/UV<sub>b</sub>) signal level relative to the measured value determines the state of the INT pin.

#### SDA/SMBDAT

SDA/SMBDAT is the serial data input/output pin. SDA/SMBDAT is a bidirectional pin used to transfer data to and from the device. The pin is an open-drain output and may be wired with other open-drain/collector outputs. The open-drain output requires a pull-up resistor for proper functionality. The pull-up resistor should be connected to VCC of the device.

#### SCL/SMBCLK

SCL/SMBCLK is the serial clock input pin. The SCL/SMBCLK input is responsible for clocking in all data to and from the device.

#### VCC

VCC is the positive supply voltage pin. VCC is an analog power pin. VCC supplies power to the device.

#### GND

GND is the ground pin. All voltages internal to the chip are referenced to ground. GND should be tied to 0V for single supply applications. For dual supply applications, the pin should be connected to the most negative voltage in the application.

#### VBUS

VBUS is the power bus voltage input pin. The pin should be connected to the desired power supply bus to be monitored.

#### VINP

VINP is the shunt voltage monitor positive input pin. The pin connects to the most positive voltage of the current shunt resistor.

#### VINM

VINM is the shunt voltage monitor negative input pin. The pin connects to the most negative voltage of the current shunt resistor.

# ISL28022

TABLE 2. ISL28022 REGISTER DESCRIPTIONS

| REGISTER ADDRESS (HEX) | REGISTER NAME           | FUNCTION  | POWER-ON RESET VALUE (HEX) | ACCESS |
|------------------------|-------------------------|---|----------------------------|--------|
| 00                     | Configuration           | Power-on reset, bus and shunt ranges, ADC acquisition times, mode configuration | 799F                       | R/W    |
| 01                     | Shunt Voltage           | Shunt voltage measurement value   | 0000                       | R      |
| 02                     | Bus Voltage             | Bus voltage measurement value   | 0000                       | R      |
| 03                     | Power                   | Power measurement value   | 0000                       | R      |
| 04                     | Current                 | Current measurement value   | 0000                       | R      |
| 05                     | Calibration Register    | Register used to enable current and power measurements.                         | 0000                       | R/W    |
| 06                     | Shunt Voltage Threshold | Min/Max shunt thresholds  | 7F81                       | R/W    |
| 07                     | Bus Voltage Threshold   | Min/Max V <sub>BUS</sub> thresholds   | FF00                       | R/W    |
| 08                     | DCS Interrupt Status    | Threshold interrupts  | 0000                       | R/W    |
| 09                     | Aux Control Register    | Register to control the interrupts and external clock functionality             | 0000                       | R/W    |

TABLE 3. CONFIGURATION REGISTER

| BIT  | D15 | D14   | D13   | D12 | D11 | D10   | D9    | D8    | D7    | D6    | D5    | D4    | D3    | D2    | D1    | D0    |
|------|-----|-------|-------|-----|-----|-------|-------|-------|-------|-------|-------|-------|-------|-------|-------|-------|
| NAME | RST | BRNG1 | BRNG0 | PG1 | PG0 | BADC3 | BADC2 | BADC1 | BADC0 | SADC3 | SADC2 | SADC1 | SADC0 | MODE2 | MODE1 | MODE0 |

## Register Descriptions

[Table 2](#) is the register map for the device. The table describes the function of each register and its respective value. The addresses are sequential and the register size is 16 bits (2 bytes) per address.

## CONFIGURATION REGISTER

The configuration register ([Table 3](#)) controls the functionality of the chip. ADC measurable range, converter acquisition times, converter resolution and state machine modes are configurable bits within this register.

### RST: Reset Bit

Configuring the reset bit (Bit 15) to a 1 generates a system reset that initializes all registers to their default values and performs a system calibration.

### BRNG: Bus Voltage Range

Bits 13 and 14 of the configuration register sets the bus measurable voltage range. [Table 4](#) shows the BRNG bit configurations versus the allowable full-scale measurement range. The shaded row is the power-up default.

TABLE 4. BRNG BIT SETTINGS

| BRNG1 | BRNG0 | USABLE FULL SCALE RANGE (V) |
|-------|-------|-----------------------------|
| 0     | 0     | 16                          |
| 0     | 1     | 32                          |
| 1     | 0     | 60                          |
| 1     | 1     | 60                          |

### PG: PGA (Shunt Voltage Only)

Bits 11 and 12 of the configuration register determines the shunt voltage measurement range. [Table 5](#) shows the PGA bit configurations versus the allowable full-scale measurement range. The shaded row is the power-up default.

TABLE 5. PGA BIT SETTINGS

| PG1 | PG0 | GAIN | RANGE (mV) |
|-----|-----|------|------------|
| 0   | 0   | 1    | ±40        |
| 0   | 1   | ÷2   | ±80        |
| 1   | 0   | ÷4   | ±160       |
| 1   | 1   | ÷8   | ±320       |

# ISL28022

## BADC: Bus ADC Resolution/Averaging

Bits [10:7] of the configuration register sets the ADC resolution/averaging when the ADC is configured in the  $V_{BUS}$  mode. The ADC can be configured versus bit accuracy. The bit accuracy selections range from 12 to 15 bits. The ADC is configurable versus the number of averages. The selection ranges from 2 to 128 samples. [Table 6](#) shows the breakdown of each BADC setting. The shaded row is the default setting upon power-up.

## SADC: Shunt ADC Resolution/Averaging

Bits [10:7] of the configuration register sets the ADC resolution/averaging when the ADC is configured in the  $V_{SHUNT}$  mode. The ADC can be configured versus bit accuracy. The bit accuracy

selections range from 12 to 15 bits. The ADC is configurable versus number of averages. The selection ranges from 2 to 128 samples. [Table 6](#) shows the breakdown of each SADC setting. The shaded row is the default setting upon power-up.

## MODE: Operating Mode

Bits [2:0] of the configuration register controls the state machine within the chip. The state machine globally controls the overall functionality of the chip. [Table 7](#) shows the various states the chip can be configured to, as well as the mode bit definitions to achieve a desired state. The shaded row is the default setting upon power-up.

TABLE 6. ADC SETTINGS, APPLIES TO BOTH SADC AND BADC CONTROL

| ADC3 | ADC2 | ADC1 | ADC0 | MODE/SAMPLES | CONVERSION TIME |
|------|------|------|------|--------------|-----------------|
| 0    | X    | 0    | 0    | 12-bit       | 72 $\mu$ s      |
| 0    | X    | 0    | 1    | 13-bit       | 132 $\mu$ s     |
| 0    | X    | 1    | 0    | 14-bit       | 258 $\mu$ s     |
| 0    | X    | 1    | 1    | 15-bit       | 508 $\mu$ s     |
| 1    | 0    | 0    | 0    | 15-bit       | 508 $\mu$ s     |
| 1    | 0    | 0    | 1    | 2            | 1.01ms          |
| 1    | 0    | 1    | 0    | 4            | 2.01ms          |
| 1    | 0    | 1    | 1    | 8            | 4.01ms          |
| 1    | 1    | 0    | 0    | 16           | 8.01ms          |
| 1    | 1    | 0    | 1    | 32           | 16.01ms         |
| 1    | 1    | 1    | 0    | 64           | 32.01ms         |
| 1    | 1    | 1    | 1    | 128          | 64.01ms         |

TABLE 7. OPERATING MODE SETTINGS

| MODE2 | MODE1 | MODE0 | MODE                      |
|-------|-------|-------|---------------------------|
| 0     | 0     | 0     | Power-down                |
| 0     | 0     | 1     | Shunt voltage, triggered  |
| 0     | 1     | 0     | Bus voltage, triggered    |
| 0     | 1     | 1     | Shunt and bus, triggered  |
| 1     | 0     | 0     | ADC off (disabled)        |
| 1     | 0     | 1     | Shunt Voltage, continuous |
| 1     | 1     | 0     | Bus voltage, continuous   |
| 1     | 1     | 1     | Shunt and bus, continuous |

## SHUNT VOLTAGE REGISTER 01H (READ-ONLY)

The shunt voltage register reports the measured value across the shunt pins (VINP and VINM) into the register. The shunt register LSB is independent of PGA range settings. The PGA setting for the shunt register masks the unused most significant bit with a sign bit. For lower range of PGA settings, multiple sign bits are returned by the DPM. Only one sign bit should be used to calculate the measured value.

Tables 8 through 11 show the weights of each bit for various PGA ranges. The tables should be used to calculate the measured value across the shunt pins from the binary to decimal domains.

To calculate the measured decimal value across the shunt, first read the shunt voltage register. Assume the PGA setting is set to the 80mV range. For this example, the reading output by the chip

is 1111 1010 0000 0101. The 80mV range has three sign bits. Only one sign bit needs to be used to calculate the measured decimal value. Bits 14 and 15 are omitted from the calculation. This leaves a binary reading of 11 1010 0000 0101.

Next, multiply each bit by its respective weight. Bit0 value would be multiplied by Bit0 weight (1), Bit1 value\*Bit1 weight (2), etc.

Add all the multiplied values to equate to a single number. For the binary reading 11 1010 0000 0101 this equates to -1531.

The LSB for a shunt register is 10µV. Multiplying the decimal value by the LSB weight yields the measured voltage across the shunt. A 1111.1010 0000 0101 reading equals -15.31mV measured across the shunt pins.

**TABLE 8. SHUNT VOLTAGE REGISTER, PG GAIN = /8 (RANGE = 11), FULL-SCALE = ±320mV, 15 BITS WIDE**

| BIT    | D15    | D14   | D13   | D12   | D11   | D10   | D9   | D8   | D7   | D6   | D5   | D4   | D3   | D2   | D1   | D0   |
|--------|--------|-------|-------|-------|-------|-------|------|------|------|------|------|------|------|------|------|------|
| NAME   | Sign   | Bit14 | Bit13 | Bit12 | Bit11 | Bit10 | Bit9 | Bit8 | Bit7 | Bit6 | Bit5 | Bit4 | Bit3 | Bit2 | Bit1 | Bit0 |
| WEIGHT | -32768 | 16384 | 8192  | 4096  | 2048  | 1024  | 512  | 256  | 128  | 64   | 32   | 16   | 8    | 4    | 2    | 1    |

**TABLE 9. SHUNT VOLTAGE REGISTER, PG GAIN = /4 (RANGE = 10), FULL-SCALE = ±160mV, 14 BITS WIDE**

| BIT    | D15  | D14    | D13   | D12   | D11   | D10   | D9   | D8   | D7   | D6   | D5   | D4   | D3   | D2   | D1   | D0   |
|--------|------|--------|-------|-------|-------|-------|------|------|------|------|------|------|------|------|------|------|
| NAME   | Sign | Sign   | Bit13 | Bit12 | Bit11 | Bit10 | Bit9 | Bit8 | Bit7 | Bit6 | Bit5 | Bit4 | Bit3 | Bit2 | Bit1 | Bit0 |
| WEIGHT |      | -16384 | 8192  | 4096  | 2048  | 1024  | 512  | 256  | 128  | 64   | 32   | 16   | 8    | 4    | 2    | 1    |

**TABLE 10. SHUNT VOLTAGE REGISTER, PG GAIN = /2 (RANGE = 01), FULL-SCALE = ±80mV, 13 BITS WIDE**

| BIT    | D15  | D14  | D13   | D12   | D11   | D10   | D9   | D8   | D7   | D6   | D5   | D4   | D3   | D2   | D1   | D0   |
|--------|------|------|-------|-------|-------|-------|------|------|------|------|------|------|------|------|------|------|
| NAME   | Sign | Sign | Sign  | Bit12 | Bit11 | Bit10 | Bit9 | Bit8 | Bit7 | Bit6 | Bit5 | Bit4 | Bit3 | Bit2 | Bit1 | Bit0 |
| WEIGHT |      |      | -8192 | 4096  | 2048  | 1024  | 512  | 256  | 128  | 64   | 32   | 16   | 8    | 4    | 2    | 1    |

**TABLE 11. SHUNT VOLTAGE REGISTER, PG GAIN = /1 (RANGE = 00), FULL-SCALE = ±40mV, 12 BITS WIDE**

| BIT    | D15  | D14  | D13  | D12   | D11   | D10   | D9   | D8   | D7   | D6   | D5   | D4   | D3   | D2   | D1   | D0   |
|--------|------|------|------|-------|-------|-------|------|------|------|------|------|------|------|------|------|------|
| NAME   | Sign | Sign | Sign | Sign  | Bit11 | Bit10 | Bit9 | Bit8 | Bit7 | Bit6 | Bit5 | Bit4 | Bit3 | Bit2 | Bit1 | Bit0 |
| WEIGHT |      |      |      | -4096 | 2048  | 1024  | 512  | 256  | 128  | 64   | 32   | 16   | 8    | 4    | 2    | 1    |

**TABLE 12. BUS VOLTAGE REGISTER, BRNG = 10 OR 11, FULL-SCALE = 60V, 14 BITS WIDE**

| BIT    | D15   | D14   | D13   | D12   | D11  | D10  | D9   | D8   | D7   | D6   | D5   | D4   | D3   | D2   | D1   | D0  |
|--------|-------|-------|-------|-------|------|------|------|------|------|------|------|------|------|------|------|-----|
| NAME   | Bit13 | Bit12 | Bit11 | Bit10 | Bit9 | Bit8 | Bit7 | Bit6 | Bit5 | Bit4 | Bit3 | Bit2 | Bit1 | Bit0 | CNVR | OVF |
| WEIGHT | 8192  | 4096  | 2048  | 1024  | 512  | 256  | 128  | 64   | 32   | 16   | 8    | 4    | 2    | 1    |      |     |

**TABLE 13. BUS VOLTAGE REGISTER, BRNG = 01, FULL-SCALE = 32V, 13 BITS WIDE**

| BIT    | D15   | D14   | D13   | D12  | D11  | D10  | D9   | D8   | D7   | D6   | D5   | D4   | D3   | D2 | D1   | D0  |
|--------|-------|-------|-------|------|------|------|------|------|------|------|------|------|------|----|------|-----|
| NAME   | Bit12 | Bit11 | Bit10 | Bit9 | Bit8 | Bit7 | Bit6 | Bit5 | Bit4 | Bit3 | Bit2 | Bit1 | Bit0 |    | CNVR | OVF |
| WEIGHT | 4096  | 2048  | 1024  | 512  | 256  | 128  | 64   | 32   | 16   | 8    | 4    | 2    | 1    |    |      |     |

**TABLE 14. BUS VOLTAGE REGISTER, BRNG = 00, FULL-SCALE = 16V, 12 BITS WIDE**

| BIT    | D15 | D14   | D13   | D12  | D11  | D10  | D9   | D8   | D7   | D6   | D5   | D4   | D3   | D2 | D1   | D0  |
|--------|-----|-------|-------|------|------|------|------|------|------|------|------|------|------|----|------|-----|
| NAME   |     | Bit11 | Bit10 | Bit9 | Bit8 | Bit7 | Bit6 | Bit5 | Bit4 | Bit3 | Bit2 | Bit1 | Bit0 |    | CNVR | OVF |
| WEIGHT |     | 2048  | 1024  | 512  | 256  | 128  | 64   | 32   | 16   | 8    | 4    | 2    | 1    |    |      |     |

**TABLE 15. CALIBRATION REGISTER, 05h**

| BIT  | D15  | D14  | D13  | D12  | D11  | D10  | D9  | D8  | D7  | D6  | D5  | D4  | D3  | D2  | D1  | D0 |
|------|------|------|------|------|------|------|-----|-----|-----|-----|-----|-----|-----|-----|-----|----|
| NAME | FS15 | FS14 | FS13 | FS12 | FS11 | FS10 | FS9 | FS8 | FS7 | FS6 | FS5 | FS4 | FS3 | FS2 | FS1 | 0  |



## BUS VOLTAGE REGISTER 02h (READ-ONLY)

The bus voltage register is where the DPM reports the measured value of the  $V_{BUS}$ . There are three scale ranges possible depending on the BRNG setting controlled from the configuration register (00h).

Tables 12 through 14 on page 16 are the weight bits for each BRNG setting. The binary value recorded in the Bus Voltage register is translated to a decimal value in the same way as the shunt voltage register is converted to a decimal value.

$$V_{bus} = \left[ \sum_{n=2}^{15} (\text{Bit}_n \cdot \text{Bit\_Weight}_n) \right] \cdot V_{bus\_LSB} \quad (\text{EQ. 1})$$

Equation 1 is the mathematical equation for converting the binary  $V_{BUS}$  value to a decimal value. N is the bit number. The LSB value for the  $V_{BUS}$  measurement equals 4mV across all bus range (BRNG) settings.

### CNVR: Conversion Ready (Bit 1)

The conversion ready bit indicates when the ADC has finished a conversion and transferred the reading(s) to the appropriate register(s). The CNVR is only operable when the DPM is set to one of three trigger modes. The CNVR is at a low state when the conversion is in progress. The CNVR transitions and remains at a high state when the conversion is complete.

The CNVR bit is initialized or reinitialized in the following ways:

1. Writing to the configuration register.
2. Reading from power register.

### OVF: Math Overflow Flag (Bit0)

The Math Overflow Flag (OVF) is a bit that is set to indicate the current or power data being read from the DPM is over-ranged and meaningless.

## CALIBRATION REGISTER 05h (READ/WRITE)

To accurately read the current and power measurements from the chip, the calibration register needs to be programmed.

The calibration register value is calculated as follows:

1. Calculate the full-scale current range that is desired. This is calculated using Equation 2.  $R_{shunt}$  is the value of the shunt resistor.  $V_{shunt\_FS}$  is the full-scale setting that is desired. In most cases, it is the PGA full-scale range (320mV, 160mV, 80mV and 40mV) that the DPM is programmed to.

$$\text{Current}_{FS} = \frac{V_{shunt\_FS}}{R_{shunt}} \quad (\text{EQ. 2})$$

2. From the current full-scale range, the current LSB is calculated using Equation 3. Current full-scale is the outcome from Equation 2.  $ADC_{res}$  is the resolution of shunt voltage reading. The value is determined by the SADC setting in configuration register. SADC setting equal to 3 and greater will have a 15-bit resolution. The  $ADC_{res}$  value equals  $2^{15}$  or 32768.

$$\text{Current}_{LSB} = \frac{\text{Current}_{FS}}{ADC_{res}} \quad (\text{EQ. 3})$$

3. From Equation 3, the calibration register value is calculated using Equation 4. The resolution of the math that is processed internally in the DPM is 4096 or 12 bits of resolution. The  $V_{shunt\_LSB}$  is set to 10 $\mu$ V. Equation 4 yields a 16-bit binary number that can be written to the calibration register. The calibration value can only be 15 bits due to the  $ADC_{res}$  value. Bit 0 of the calibration register is fixed to a value of 0. The calibration register format is represented in Table 15.

$$\text{CalReg}_{val} = \text{integer} \left[ \frac{\text{Math}_{res} \cdot V_{shunt\_LSB}}{(\text{Current}_{LSB} \cdot R_{shunt})} \right]$$

$$\text{CalReg}_{val} = \text{integer} \left[ \frac{0.04096}{(\text{Current}_{LSB} \cdot R_{shunt})} \right] \quad (\text{EQ. 4})$$

## CURRENT REGISTER 04h (READ-ONLY)

Once the calibration register (05h) is programmed, the output current is calculated using Equation 5:

$$\text{Current} = \left[ \sum_{n=0}^{15} (\text{Bit}_n \cdot \text{Bit\_Weight}_n) \right] \cdot \text{Current}_{LSB} \quad (\text{EQ. 5})$$

Bit is the returned value of each bit from the current register either 1 or a 0. The weight of each bit is represented in Table 16. n is the bit number. The current LSB is the value calculated from Equation 3.

## POWER REGISTER 03h (READ-ONLY)

The Power register only has meaning if the calibration register (05h) is programmed. The units for the power register are in watts. The power is calculated using Equation 6:

$$\text{Power} = \left[ \sum_{n=0}^{15} (\text{Bit}_n \cdot \text{Bit\_Weight}_n) \right] \cdot \text{Power}_{LSB} \cdot 5000 \quad (\text{EQ. 6})$$

Bit is the returned value of each bit from the power register either 1 or a 0. The weight of each bit is represented in Table 17. n is the bit number. The power LSB is calculated from Equation 7:

$$\text{Power}_{LSB} = \text{Current}_{LSB} \cdot V_{bus\_LSB} \quad (\text{EQ. 7})$$

If  $V_{BUS}$  range, BRNG, is set to 60V, the power equation in Equation 6 is multiplied by 2.

## THRESHOLD REGISTERS

The Shunt Voltage or  $V_{BUS}$  threshold registers are used to set the Min/Max threshold limits that will be tested versus  $V_{SHUNT}$  or  $V_{BUS}$  readings. Measurement readings exceeding the respective  $V_{SHUNT}$  or  $V_{BUS}$  limits, either above or below, will set a register flag and perhaps an external interrupt depending on the configuration of the Interrupt Enable bit (INTREN) in register 09h. The testing of the ADC reading versus the respective threshold limits occurs once per ADC conversion.

## SHUNT VOLTAGE THRESHOLD REGISTER 06h (READ/WRITE)

The  $V_{SHUNT}$  minimum and maximum threshold limits are set using one register. The shunt value readings are either positive or negative. D15 and D7 bits of [Table 18](#) are given to represent the sign of the limit. SMX bits represent the upper limit threshold. SMN represents the lower threshold limit. [Equation 8](#) is the calculation used to convert the  $V_{SHUNT}$  threshold binary value to

decimal. Bit is the value of each bit set in the shunt threshold register. The value is either 1 or a 0. The weight of each bit is represented in [Table 18](#). n is the bit number. The shunt voltage threshold LSB is 2.56mV.

$$V_{s \text{ thresh}} = \left[ \sum_{n=0}^{7} (\text{Bit}_n \cdot \text{Bit\_Weight}_n) \right] \cdot V_{s \text{ Thresh\_LSB}} \quad (\text{EQ. 8})$$

TABLE 16. CURRENT REGISTER, 04h

| BIT    | D15    | D14   | D13   | D12   | D11   | D10   | D9   | D8   | D7   | D6   | D5   | D4   | D3   | D2   | D1   | D0   |
|--------|--------|-------|-------|-------|-------|-------|------|------|------|------|------|------|------|------|------|------|
| NAME   | Bit 15 | Bit14 | Bit13 | Bit12 | Bit11 | Bit10 | Bit9 | Bit8 | Bit7 | Bit6 | Bit5 | Bit4 | Bit3 | Bit2 | Bit1 | Bit0 |
| WEIGHT | -32768 | 16384 | 8192  | 4096  | 2048  | 1024  | 512  | 256  | 128  | 64   | 32   | 16   | 8    | 4    | 2    | 1    |

TABLE 17. POWER REGISTER, 03h

| BIT    | D15   | D14   | D13  | D12  | D11  | D10  | D9  | D8  | D7  | D6  | D5  | D4  | D3  | D2  | D1  | D0  |
|--------|-------|-------|------|------|------|------|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|
| NAME   | PD15  | PD14  | PD13 | PD12 | PD11 | PD10 | PD9 | PD8 | PD7 | PD6 | PD5 | PD4 | PD3 | PD2 | PD1 | PD0 |
| WEIGHT | 32768 | 16384 | 8192 | 4096 | 2048 | 1024 | 512 | 256 | 128 | 64  | 32  | 16  | 8   | 4   | 2   | 1   |

TABLE 18. SHUNT VOLTAGE THRESHOLD REGISTER, 06h

| BIT    | D15  | D14  | D13  | D12  | D11  | D10  | D9   | D8   | D7   | D6   | D5   | D4   | D3   | D2   | D1   | D0   |
|--------|------|------|------|------|------|------|------|------|------|------|------|------|------|------|------|------|
| NAME   | Sign | SMX6 | SMX5 | SMX4 | SMX3 | SMX2 | SMX1 | SMX0 | Sign | SMN6 | SMN5 | SMN4 | SMN3 | SMN2 | SMN1 | SMN0 |
| WEIGHT | -128 | 64   | 32   | 16   | 8    | 4    | 2    | 1    | -128 | 64   | 32   | 16   | 8    | 4    | 2    | 1    |

TABLE 19. BUS VOLTAGE THRESHOLD REGISTER, 07h

| BIT    | D15  | D14  | D13  | D12  | D11  | D10  | D9   | D8   | D7   | D6   | D5   | D4   | D3   | D2   | D1   | D0   |
|--------|------|------|------|------|------|------|------|------|------|------|------|------|------|------|------|------|
| NAME   | BMX7 | BMX6 | BMX5 | BMX4 | BMX3 | BMX2 | BMX1 | BMX0 | BMN7 | BMN6 | BMN5 | BMN4 | BMN3 | BMN2 | BMN1 | BMN0 |
| WEIGHT | 128  | 64   | 32   | 16   | 8    | 4    | 2    | 1    | 128  | 64   | 32   | 16   | 8    | 4    | 2    | 1    |

TABLE 20. INTERRUPT STATUS REGISTER, 08h

| BIT    | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 | D7 | D6 | D5 | D4 | D3   | D2   | D1   | D0   |
|--------|-----|-----|-----|-----|-----|-----|----|----|----|----|----|----|------|------|------|------|
| NAME   | NA  | NA  | NA  | NA  | NA  | NA  | NA | NA | NA | NA | NA | NA | SMXW | SMNW | BMXW | BMNW |
| WEIGHT | 0   | 0   | 0   | 0   | 0   | 0   | 0  | 0  | 0  | 0  | 0  | 0  | 0    | 0    | 0    | 0    |

TABLE 21. AUX CONTROL REGISTER, 09h

| BIT    | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8        | D7     | D6       | D5             | D4 | D3 | D2 | D1 | D0 |
|--------|-----|-----|-----|-----|-----|-----|----|-----------|--------|----------|----------------|----|----|----|----|----|
| NAME   | NA  | NA  | NA  | NA  | NA  | NA  | NA | FORCEINTR | INTREN | ExtClkEn | ExtCLKDiv[5:0] |    |    |    |    |    |
| WEIGHT | 0   | 0   | 0   | 0   | 0   | 0   | 0  | 0         | 0      | 0        | 0              | 0  | 0  | 0  | 0  | 0  |

## BUS VOLTAGE THRESHOLD REGISTER 07h (READ/WRITE)

The  $V_{BUS}$  minimum and maximum threshold limits are set using one register. The  $V_{BUS}$  value readings range from 0V to 60V. [Table 19 on page 18](#) shows the register configuration and bit weights for the  $V_{BUS}$  threshold register. BMX bits represent the upper limit threshold. BMN represents the lower threshold limit. [Equation 9](#) is the calculation used to convert the  $V_{BUS}$  threshold binary value to decimal. Bit is the value of each bit set in the  $V_{BUS}$  threshold register. The value is either 1 or a 0. The weight of each bit is represented in [Table 19](#). n is the bit number. The  $V_{BUS}$  voltage threshold LSB is 256mV.

$$V_{b_{thresh}} = \left[ \sum_{n=0}^7 \left( \text{Bit}_n \cdot \text{Bit\_Weight}_n \right) \right] \cdot V_{b_{Thresh\_LSB}} \quad (\text{EQ. 9})$$

## INTERRUPT STATUS REGISTER 08h (READ/WRITE)

The interrupt status register consists of a series of bit flags that indicate if an ADC reading has exceeded the readings respective limit. A 1 or high reading from a warning bit indicates the reading has exceeded the limit. To clear a warning, write a 1 or high to the set warning bit. [Table 20 on page 18](#) shows the definition of the interrupt status register.

BMNW is the Bus voltage Minimum Warning. A “1” reading for this bit indicates the bus reading is below the bus voltage minimum threshold limit.

BMXW is the Bus voltage Maximum Warning. A “1” reading for this bit indicates the bus reading is above the bus voltage maximum threshold limit.

SMNW is the Shunt voltage Minimum Warning. A “1” reading for this bit indicates the shunt reading is below the shunt voltage minimum threshold limit.

SMXW is the Shunt voltage Maximum Warning. A “1” reading for this bit indicates the shunt reading is above the shunt voltage maximum threshold limit.

## AUX CONTROL REGISTER 09h (READ/WRITE)

The Aux control register controls the functionality of the EXTCLK/INT pin of the ISL28022. [Table 21 on page 18](#) shows the definition of the register.

FORCEINTR is the Force Interrupt bit. Programming a 1 to the bit will force a 0 or a low at the EXTCLK/INT pin.

INTREN is the Interrupt Enable bit. Programming a 1 to the bit will allow for a threshold measurement violation to set the state of the EXTCLK/INT pin. With the INTREN set, any flag set from the interrupt status register will change the state of the EXTCLK/INT pin from 1 to a 0.

EXCLKEN is the External Clock Enable bit. Setting the bit enables the external clock. This also changes the EXTCLK/INT pin from an output to an input. The internal oscillator will shut down when the bit is enabled.

EXTCLKDIV are the External Clock Divider bits. The bits control an internal clock divider that are useful for fast system clocks. The internal clock frequency from pin to chip is represented in [Equation 10](#):

$$f_{\text{req internal}} = \frac{f_{\text{EXTCLK}}}{(\text{EXTCLKDIV} + 1) \cdot 2} \quad (\text{EQ. 10})$$

$f_{\text{EXTCLK}}$  is the frequency of the signal driven to the EXTCLK/INT pin. EXTCLKDIV is the decimal value of the clock divide bits.

## Serial Interface

The ISL28022 supports a bidirectional bus oriented protocol. The protocol defines any device that sends data onto the bus as a transmitter and the receiving device as the receiver. The device controlling the transfer is the master and the device being controlled is the slave. The master always initiates data transfers and provides the clock for both transmit and receive operations. Therefore, the ISL28022 operates as a slave device in all applications.

The ISL28022 uses two bytes to transfer all reads and writes. All communication over the I<sup>2</sup>C interface is conducted by sending the MSByte of each byte of data first, followed by the LSByte.

## Protocol Conventions

For normal operation, data states on the SDA line can change only during SCL LOW periods. SDA state changes during SCL HIGH are reserved for indicating START and STOP conditions (see [Figure 27](#)). On power-up of the ISL28022, the SDA pin is in the input mode.

All I<sup>2</sup>C interface operations must begin with a START condition, which is a HIGH to LOW transition of SDA while SCL is HIGH. The ISL28022 continuously monitors the SDA and SCL lines for the START condition and does not respond to any command until this condition is met (see [Figure 27](#)). A START condition is ignored during the power-up sequence.

All I<sup>2</sup>C interface operations must be terminated by a STOP condition, which is a LOW to HIGH transition of SDA while SCL is HIGH (see [Figure 27](#)). A STOP condition at the end of a read operation or at the end of a write operation places the device in its standby mode.

## SMBus Support

The ISL28022 supports SMBus protocol, which is a subset of the global I<sup>2</sup>C protocol. SMBCLK and SMBDAT have the same pin functionality as the SCL and SDA pins, respectively. The SMBus operates at 100kHz.

# ISL28022

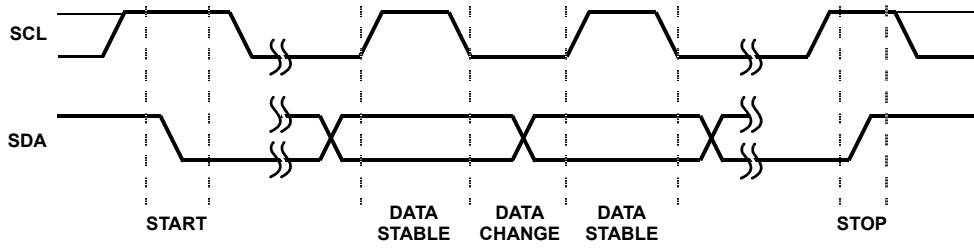


FIGURE 27. VALID DATA CHANGES, START AND STOP CONDITIONS

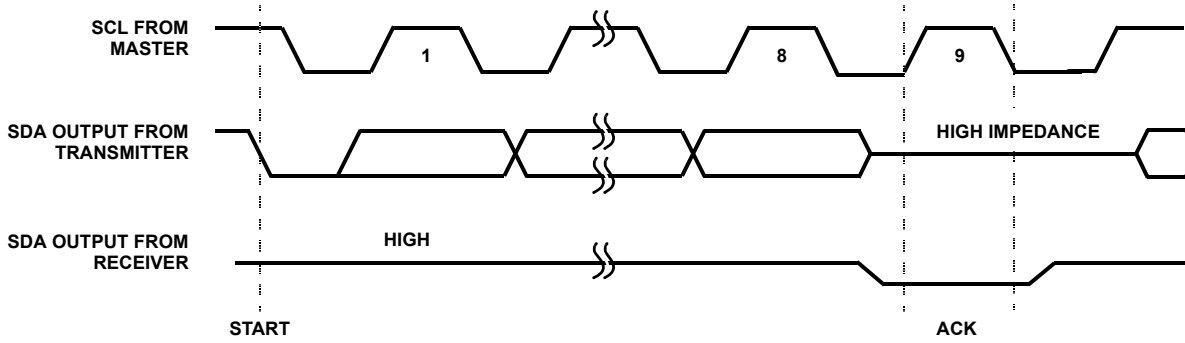


FIGURE 28. ACKNOWLEDGE RESPONSE FROM RECEIVER

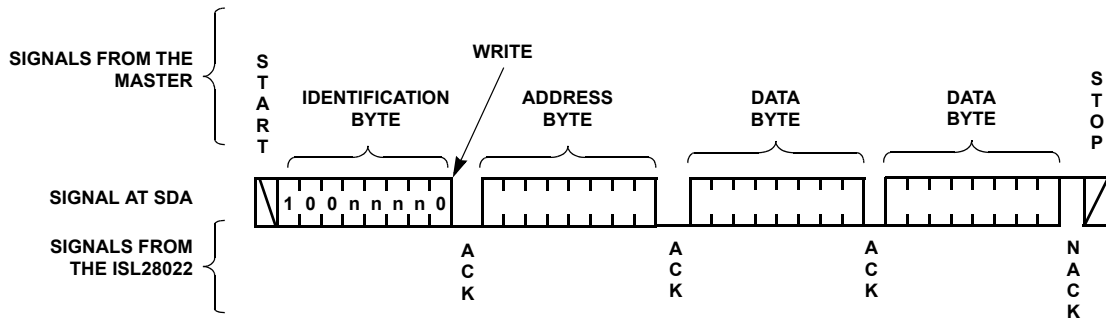


FIGURE 29. BYTE WRITE SEQUENCE (SLAVE ADDRESS INDICATED BY nnnn)

## Device Addressing

Following a start condition, the master must output a slave address byte. The 7 MSBs are the device identifiers. The A0 and A1 pins control the bus address (these bits are shown in [Table 22](#)). There are 16 possible combinations depending on the A0/A1 connections. The last bit of the slave address byte defines a read or write operation to be performed. When this R/W bit is a “1”, a read operation is selected. A “0” selects a write operation (refer to [Figure 29](#)).

After loading the entire slave address byte from the SDA bus, the ISL28022 compares the loaded value to the internal slave

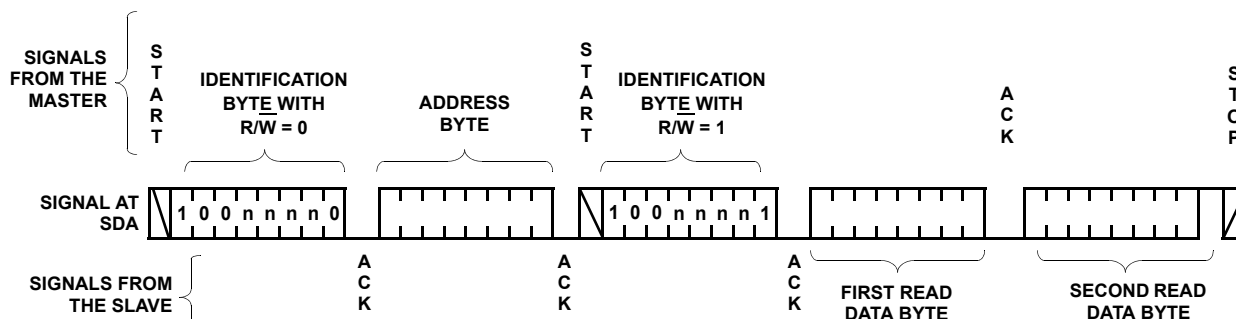
address. Upon a correct compare, the device outputs an acknowledge on the SDA line.

Following the slave byte is a one byte word address. The word address is either supplied by the master device or obtained from an internal counter. On power-up, the internal address counter is set to address 00h, so a current address read starts at address 00h. When required, as part of a random read, the master must supply the one word address byte, as shown in [Figure 30](#).

In a random read operation, the slave byte in the “dummy write” portion must match the slave byte in the “read” section. For a random read of the registers, the slave byte must be “100nnnnx” in both places.

**TABLE 22. I<sup>2</sup>C SLAVE ADDRESSES**

| A1                | A0  | SLAVE ADDRESS |
|-------------------|-----|---------------|
| GND               | GND | 1000 000      |
| GND               | VCC | 1000 001      |
| GND               | SDA | 1000 010      |
| GND               | SCL | 1000 011      |
| VCC               | GND | 1000 100      |
| VCC               | VCC | 1000 101      |
| VCC               | SDA | 1000 110      |
| VCC               | SCL | 1000 111      |
| SDA               | GND | 1001 000      |
| SDA               | VCC | 1001 001      |
| SDA               | SDA | 1001 010      |
| SDA               | SCL | 1001 011      |
| SCL               | GND | 1001 100      |
| SCL               | VCC | 1001 101      |
| SCL               | SDA | 1001 110      |
| SCL               | SCL | 1001 111      |
| Broadcast Address |     | 0111 111      |



**FIGURE 30. READ SEQUENCE (SLAVE ADDRESS SHOWN AS nnnn)**

## Write Operation

A write operation requires a START condition, followed by a valid identification byte, a valid address byte, two data bytes and a STOP condition. The first data byte contains the MSB of the data, the second contains the LSB. After each of the four bytes, the ISL28022 responds with an ACK. At this time, the I<sup>2</sup>C interface enters a standby state.

## Read Operation

A read operation consists of a three byte instruction, followed by two data bytes (see [Figure 30 on page 21](#)). The master initiates the operation issuing the following sequence: A START, the identification byte with the R/W bit set to "0", an address byte, a second START and a second identification byte with the R/W bit set to "1". After each of the three bytes, the ISL28022 responds with an ACK. Then the ISL28022 transmits two data bytes as long as the master responds with an ACK during the SCL cycle following the eighth bit of the first byte. The master terminates the read operation (issuing no ACK then a STOP condition) following the last bit of the second data byte (see [Figure 30 on page 21](#)).

The data bytes are from the memory location indicated by an internal pointer. This pointer's initial value is determined by the address byte in the read operation instruction and increments by one during transmission of each pair of data bytes. The highest valid memory location is 09h, reads of addresses higher than that will not return useful data.

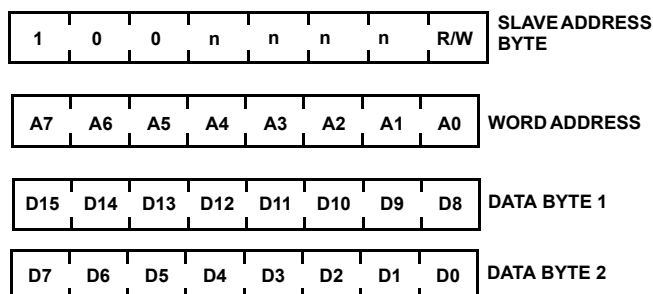


FIGURE 31. SLAVE ADDRESS, WORD ADDRESS AND DATA BYTES

## Broadcast Addressing

The DPM has a feature that allows the user to configure the settings of all DPM chips at once. For example, a system has 16 DPM chips connected to an I<sup>2</sup>C bus. A user can set the range or initiate a data acquisition in one I<sup>2</sup>C data transaction by using a slave address of 0111 111. The broadcast feature saves time in configuring the DPM as well as measuring signal parameters in time synchronization. The broadcast should not be used for DPM read backs. This will cause all devices connected to the I<sup>2</sup>C bus to talk to the master simultaneously.

## I<sup>2</sup>C Clock Speed

The device supports high-speed digital transactions up to 3.4Mbs. To access the high speed I<sup>2</sup>C feature, a master byte code of 0000 1xxx is attached to the beginning of a standard frequency read/write I<sup>2</sup>C protocol. The x in the master byte signifies a do not care state. X can either equal a 0 or a 1. The master byte code should be clocked into the chip at frequencies equal or less than 400kHz. The master code command configures the internal filters of the ISL28022 to permit data bit frequencies greater than 400kHz. Once the master code has been clocked into the device, the protocol for a standard read/write transaction is followed. The frequency at which the standard protocol is clocked in at can be as great as 3.4MHz. A stop bit at the end of a standard protocol will terminate the high speed transaction mode. Appending another standard protocol serial transaction to the data string without a stop bit, will resume the high speed digital transaction mode. [Figure 32](#) illustrates the data sequence for the high speed mode.

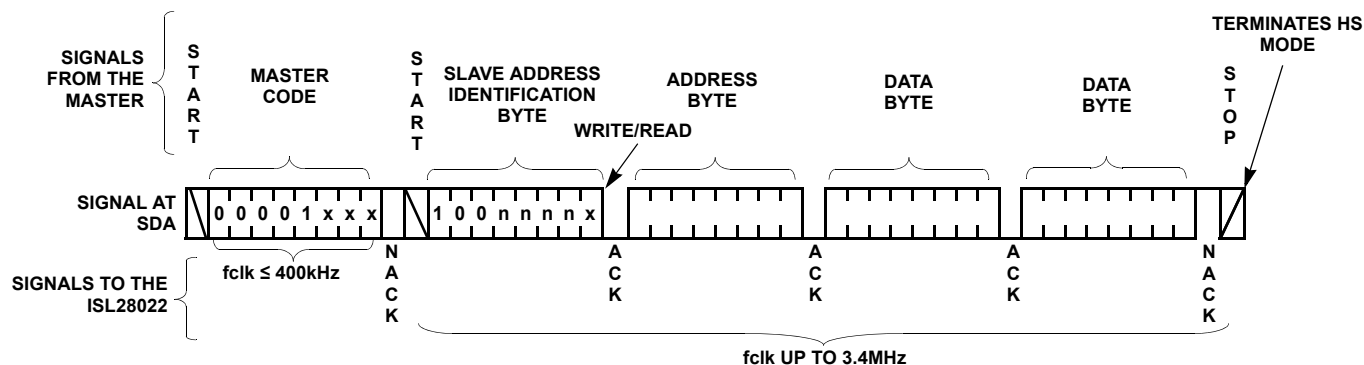


FIGURE 32. BYTE TRANSACTION SEQUENCE FOR INITIATING DATA RATES ABOVE 400kbs

## Signal Integrity

The purity of the signal being measured by the ISL28022 is not always ideal. Environmental noise or noise generated from a regulator can degrade the measurement accuracy. The ISL28022 maintains a high CMRR ratio from DC to approximately 10kHz, as shown in [Figure 33](#).

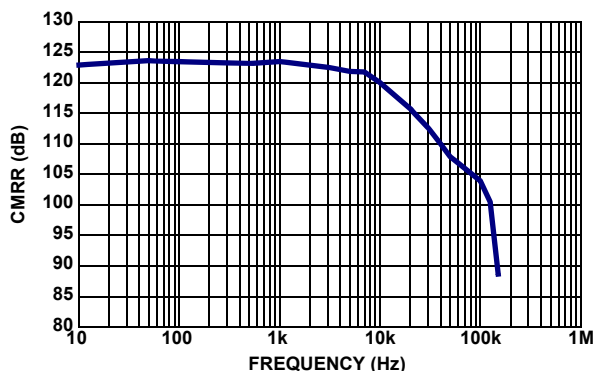


FIGURE 33. CMRR vs FREQUENCY

The CMRR vs Frequency graph best represents the response of the ISL28022 when an aberrant signal is applied to the circuit.

The graph was generated by shorting the ISL28022 input without any filtering and applying a 0V to 10V triangle wave to the Shunt inputs, VINP and VINM. The voltage shunt measurement was recorded for each frequency applied to the shunt input.

The CMRR can be improved by designing a filter stage before the ISL28022. The purpose of the filter stage is to attenuate the amplitude of the unwanted signal to the noise level of the ISL28022. [Figure 34](#) is a simple filter example to attenuate unwanted signals.

$C_{SH}$  and  $R_{SH}$  are single pole RC filters that differentially attenuate unwanted signals to the ISL28022. Most power monitoring applications require a shunt resistor to be low in value to measure large currents. For small shunt resistors, a large value capacitor is required to attenuate low frequency signals. Most large value capacitors are not offered in space saving packages. The corner frequency of the differential filter,  $C_{SH}$  and  $R_{SH}$ , should be designed for higher value frequency filtering.

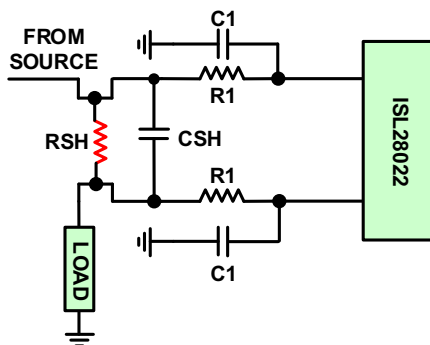


FIGURE 34. SIMPLIFIED FILTER DESIGN TO IMPROVE NOISE PERFORMANCE TO THE ISL28022

$R_1$  and  $C_1$  for both inputs are single ended low pass filters. The value of the series resistor to the ISL28022 can be a larger value than the shunt resistor,  $R_{SH}$ . A larger series resistor to the input allows for a lower cutoff frequency filter design to the ISL28022. The ISL28022 can source up to 20 $\mu$ A of transient current in the measurement mode. The transient or switching offset current can be as large as 10 $\mu$ A. The switching offset current combined with the series resistance,  $R_1$ , creates an error offset voltage. A balance of the value of  $R_1$  and the shunt measurement error should be achieved for this filter design.

The common-mode voltage of the shunt input stage ranges from 0V to 60V. The capacitor voltage rating for  $C_1$  and  $C_{SH}$  should comply with the nominal voltage being applied to the input.

## Measurement Stability vs Acquisition Time

The BADC and SADC bits within the Configuration register configures the conversion time and accuracy for the bus and shunt inputs, respectively. The faster the conversion time the less accuracy and more noise introduced into the measurement. [Figure 35](#) is a graph that illustrates the shunt measurement variability versus a set SADC mode. The standard deviation of 2048 shunt  $V_{OS}$  measurements is used to quantify the measurement variability of each mode.

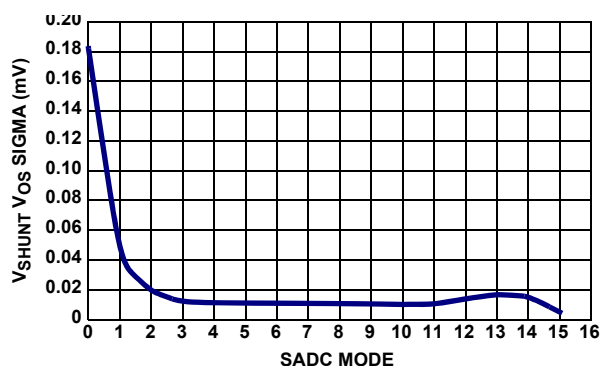


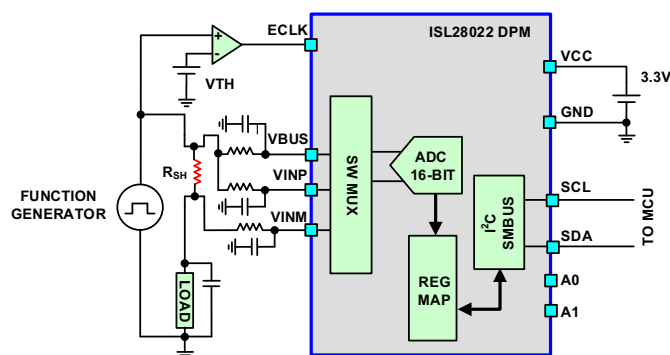
FIGURE 35. MEASUREMENT STABILITY vs SADC MODE

## Fast Transients

A small isolation resistor placed between ISL28022 inputs and the source is recommended. In hot swap or other fast transient events, the amplitude of a signal can exceed the recommended operating voltage of the part due to the line inductance. The isolation resistor creates a low pass filter between the device and the source. The value of the isolation resistor should not be too large. A large value isolation resistor can effect the measurement accuracy. The offset current for shunt input can be as large as 10 $\mu$ A. The value of the isolation resistor combined with the offset current creates an error offset voltage at the shunt input. The input of the Bus channel is connected to the top of a precision resistor divider. The accuracy of the resistor divider determines the gain error of the Bus channel. The input resistance of the Bus channel is 600k $\Omega$ . Placing an isolation resistor of the 10 $\Omega$  will change the gain error of the Bus channel by 0.0016%.



## External Clock

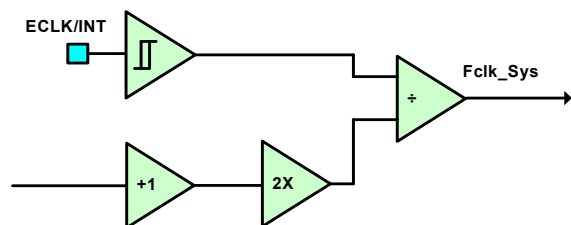


**FIGURE 36. SIMPLIFIED SCHEMATIC OF THE ISL28022 SYNCHRONIZED TO A PWM SOURCE**

An externally controlled clock allows measurements to be synchronized to an event that is time dependent. The event could be application generated, such as timing a current measurement to a charging capacitor in a switch regulator application or the event could be environmental. A voltage or current measurement may be susceptible to crosstalk from a controlled source. Instead of filtering the environmental noise from the measurement, another approach would be to synchronize the measurement to the source. The variability and accuracy of the measurement will improve.

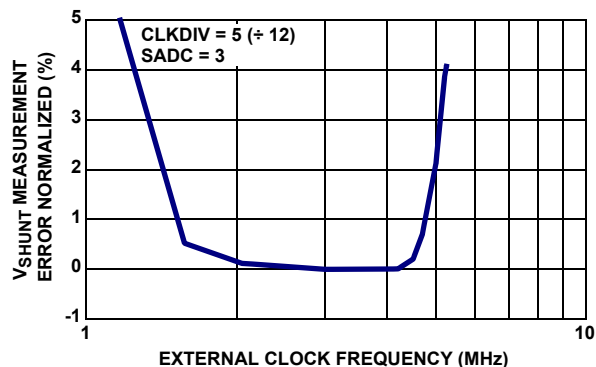
The ISL28022 has the functionality to allow for synchronization to an external clock. The speed of the external clock combined with the choice of the internal chip frequency division value determines the acquisition times of the ADC. The internal system clock frequency is 500kHz. The internal system clock is also the ADC sampling clock. The acquisition times scale linearly from 500kHz. For example, an external clock frequency of 1MHz with a frequency divide setting of 2 results in acquisition times that equals the internal oscillator frequency when enabled. The internal clock frequency of the ISL28022 should not exceed 500kHz. The ADC modulator is optimized for frequencies of 500kHz and below. Operating internal clock frequencies above 500kHz result in measurement accuracy errors due to the modulator not having enough time to settle.

Suppose an external clock frequency of 1.0MHz is applied with a divide by 8 internal frequency setting, the system clock speed is 125kHz or 4x slower than internal system clock. The acquisition times for this example will increase by 4. For a S(B)ADC setting of 3, the ISL28022 will have an acquisition time of 2.032ms instead of 508μs.



**FIGURE 37. SIMPLIFIED INTERNAL BLOCK CONNECTION OF THE ECLK/INT PIN**

The ECLK/INT pin connects to a buffer that drives a D-flip flop. [Figure 37](#) illustrates a simple schematic of the ECLK/INT pin internal connection. The series of divide by 2 configured D-flip flops are controlled by the CLKDIV bits from the Aux Control Register. The buffer is a Schmitt triggered buffer. The bandwidth of the buffer is 4MHz. [Figure 38](#) shows the bandwidth of the ECLK/INT pin.



**FIGURE 38. EXTERNAL CLOCK BANDWIDTH vs MEASUREMENT ACCURACY**

The V<sub>SHUNT</sub> measurement error degrades at ECLK frequencies above 4MHz. It is recommended that the ECLK does not exceed 4MHz. At ECLK frequencies below 2.5MHz or internal clock frequencies of 208kHz, the clock frequency to modulator is too slow allowing the charged capacitors to discharge due to parasitic leakages. The capacitor discharge results in a measurement error.

## Over-Ranging

It is not recommended to operate the ISL28022 outside the set voltage range. In the event of measuring a shunt voltage beyond the maximum set range (320mV) and lower than the clamp voltage of the protection diode (1V), the measured output reading may be within the accepted range but will be incorrect.

## Shunt Resistor Selection

In choosing a sense resistor, the following resistor parameters need to be considered: the resistor value, resistor temperature coefficient and resistor power rating.

The sense resistor value is a function of the full-scale voltage drop across the shunt resistor and the maximum current measured for the application. The ISL28022 has 4 voltage ranges that are controlled by programming the PGA bits within the configuration register. The PGA bits control the voltage range for the V<sub>SHUNT</sub> input (VINP-VINM) of the ISL28022. Once the voltage range for the input is chosen and the maximum measurable current is known, the sense resistor value is calculated using [Equation 11](#):

$$R_{\text{sense}} = \frac{V_{\text{shunt\_range}}}{I_{\text{meas\_Max}}} \quad (\text{EQ. 11})$$

In choosing a sense resistor, the sense resistor power rating should be taken into consideration. The physical size of a sense resistor is proportional to the power rating of the resistor. The maximum power rating for the measurement system is calculated as the V<sub>shunt-range</sub> multiplied by the maximum



measurable current expected. The power rating equation is represented by [Equation 12](#):

$$P_{res\_rating} = V_{shunt\_range} \cdot I_{meas\_Max} \quad (EQ. 12)$$

A general rule of thumb is to multiply the power rating calculated in [Equation 12](#) by 2. This allows the sense resistor to survive an event when the current passing through the shunt resistor is greater than the measurable maximum current. The higher the ratio between the power rating of the chosen sense resistor and the calculated power rating of the system ([Equation 12](#)), the less the resistor will heat up in high-current applications.

The Temperature Coefficient (TC) of the sense resistor directly degrades the current measurement accuracy. The surrounding temperature of the sense resistor and the power dissipated by the resistor will cause the sense resistor value to change. The change in resistor temperature with respect to the amount of current that flows through the resistor, is directly proportional to the ratio of the power rating of the resistor versus the power being dissipated. A change in sense resistor temperature results in a change in sense resistor value. Overall, the change in sense resistor value contributes to the measurement accuracy for the system. The change in a resistor value due to a temperature rise can be calculated using [Equation 13](#):

$$\Delta R_{sense} = R_{sense} \cdot R_{sense\_TC} \cdot \Delta Temperature \quad (EQ. 13)$$

$\Delta Temperature$  is the change in temperature in Celsius.  $R_{sense\_TC}$  is the temperature coefficient rating for a sense resistor.  $R_{sense}$  is the resistance value of the sense resistor at the initial temperature.

[Table 23](#) is a shunt resistor reference table for select full-scale current measurement ranges ( $I_{meas\_Max}$ ). The table also provides the minimum rating for each shunt resistor.

**TABLE 23. SHUNT RESISTOR VALUES AND POWER RATINGS FOR SELECT MEASURABLE CURRENT RANGES**

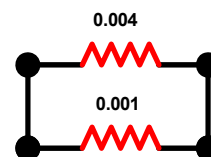
| $R_{sense}/$<br>$P_{rating}$ | $V_{SHUNT}$ RANGE (PGA SETTING) |                  |                   |                   |
|------------------------------|---------------------------------|------------------|-------------------|-------------------|
|                              | (PGA 00)<br>40mV                | (PGA 01)<br>80mV | (PGA 10)<br>160mV | (PGA 11)<br>320mV |
| $I_{meas\_Max}$              |                                 |                  |                   |                   |
| 100µA                        | 400Ω/4µW                        | 800Ω/8µW         | 1.6kΩ/16µW        | 3.2kΩ/<br>32µW    |
| 1mA                          | 40Ω/40µW                        | 80Ω/80µW         | 160Ω/160µW        | 320Ω/<br>320µW    |
| 10mA                         | 4Ω/400µW                        | 8Ω/800µW         | 16Ω/1.6mW         | 32Ω/<br>3.2mW     |
| 100mA                        | 400mΩ/4mW                       | 800mΩ/8mW        | 1.6Ω/16mW         | 3.2Ω/<br>30mW     |
| 500mA                        | 80mΩ/20mW                       | 160mΩ/40mW       | 320mΩ/<br>80mW    | 640mΩ/<br>160mW   |
| 1A                           | 40mΩ/40mW                       | 80mΩ/80mW        | 160mΩ/<br>160mW   | 320mΩ/<br>320mW   |
| 5A                           | 8mΩ/200mW                       | 16mΩ/400mW       | 32mΩ/<br>800mW    | 64mΩ/<br>1.6W     |

**TABLE 23. SHUNT RESISTOR VALUES AND POWER RATINGS FOR SELECT MEASURABLE CURRENT RANGES (Continued)**

| $R_{sense}/$<br>$P_{rating}$ | $V_{SHUNT}$ RANGE (PGA SETTING) |                  |                   |                   |
|------------------------------|---------------------------------|------------------|-------------------|-------------------|
|                              | (PGA 00)<br>40mV                | (PGA 01)<br>80mV | (PGA 10)<br>160mV | (PGA 11)<br>320mV |
| $I_{meas\_Max}$              |                                 |                  |                   |                   |
| 10A                          | 4mΩ/400mW                       | 8mΩ/800mW        | 16mΩ/1.6W         | 32mΩ/<br>3.2W     |
| 50A                          | 0.8mΩ/2W                        | 1.6mΩ/4W         | 3.2mΩ/8W          | 6.4mΩ/<br>16W     |
| 100A                         | 0.4mΩ/4W                        | 0.8mΩ/8W         | 1.6mΩ/16W         | 3.2mΩ/<br>32W     |
| 500A                         | 0.08mΩ/20W                      | 0.16mΩ/40W       | 0.32mΩ/80W        | 0.64mΩ/<br>160W   |

It is often hard to readily purchase shunt resistor values for a desired measurable current range. Either the value of the shunt resistor does not exist or the power rating of the shunt resistor is too low. A means of circumventing the problem is to use two or more shunt resistors in parallel to set the desired current measurement range. For example, an application requires a full-scale current of 50A with a maximum voltage drop across the shunt resistor of 40mV. [Table 23](#) shows this requires a sense resistor of 0.8mΩ, 2W resistor. Assume the power ratings and the shunt resistor values to choose from are 1mΩ/ 1W, 2mΩ/1W, and 4mΩ/1W.

Let's use a 1mΩ and a 4mΩ resistor in parallel to create the shunt resistor value of 0.8mΩ. [Figure 39](#) shows an illustration of the shunt resistors in parallel.

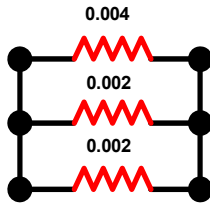


**FIGURE 39. A SIMPLIFIED SCHEMATIC ILLUSTRATING THE USE OF TWO SHUNT RESISTORS TO CREATE A DESIRED SHUNT VALUE**

The power to each shunt resistor should be calculated before calling a solution complete. The power to each shunt resistor is calculated using [Equation 14](#):

$$P_{shuntRes} = \frac{V_{shunt\_range}^2}{R_{sense}} \quad (EQ. 14)$$

The power dissipated by the 1mΩ resistor is 1.6W. 400mW is dissipated by the 4mΩ resistor. 1.6W exceeds the rating limit of 1W for the 1mΩ sense resistor. Another approach would be to use three shunt resistors in parallel as illustrated in [Figure 40](#).

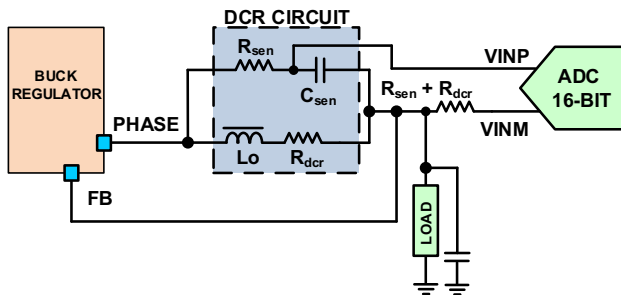


**FIGURE 40. INCREASING THE NUMBER OF SHUNT RESISTORS IN PARALLEL TO CREATE A SHUNT RESISTOR VALUE REDUCES THE POWER DISSIPATED BY EACH SHUNT RESISTOR**

Using [Equation 14 on page 25](#), the power dissipated to each shunt resistor yields 0.8W for the 2mΩ shunt resistors and 0.4W for the 4mΩ shunt resistor. All shunt resistors are within the specified power ratings.

## Lossless Current Sensing (DCR)

A DCR sense circuit is an alternative to a sense resistor. The DCR circuit utilizes the parasitic resistance of an inductor to measure the current to the load. A DCR circuit remotely measures the current through an inductor. The lack of components in series with the regulator to the load makes the circuit lossless.



**FIGURE 41. A SIMPLIFIED CIRCUIT EXAMPLE OF A DCR**

A properly matched DCR circuit has an equivalent circuit seen by the ADC equals to  $R_{dcr}$  in [Figure 41](#). Before deriving the transfer function between the inductor current and voltage seen by the ISL28022, let's review the definition of an inductor and capacitor in the Laplacian domain.

$$X_C(f) = \frac{1}{j \cdot \omega(f) \cdot C} \quad X_L(f) = j \cdot \omega(f) \cdot L \quad (\text{EQ. 15})$$

$X_C$  is the impedance of a capacitor related to the frequency and  $X_L$  is the impedance of an inductor related to frequency.  $\omega$  equals to  $2 \cdot \pi \cdot f$ .  $f$  is the chop frequency dictated by the regulator. Using Ohms law, the voltage across the DCR circuit in terms of the current flowing through the inductor is defined in [Equation 16](#).

$$V_{dcr}(f) = (R_{dcr} + j \cdot \omega(f) \cdot L) \cdot i_L \quad (\text{EQ. 16})$$

In [Equation 16](#),  $R_{dcr}$  is the parasitic resistance of the inductor. The voltage drop across the inductor ( $L_o$ ) and the resistor ( $R_{dcr}$ ) circuit is the same as the voltage drop across the resistor ( $R_{sen}$ ) and the capacitor ( $C_{sen}$ ) circuit. [Equation 17](#) defines the voltage across the capacitor ( $V_{c(sen)}$ ) in terms of the inductor current ( $i_L$ ).

$$V_{c(F)} = \left[ \frac{(j \cdot \omega(f) \cdot L + R_{dcr})}{1 + j \cdot \omega(f) \cdot C_{sen} \cdot R_{sen}} \right] \cdot i_L = R_{dcr} \cdot \left[ \frac{\left[ 1 + \frac{(j \cdot \omega(f) \cdot L)}{R_{dcr}} \right]}{1 + j \cdot \omega(f) \cdot C_{sen} \cdot R_{sen}} \right] \cdot i_L \quad (\text{EQ. 17})$$

The relationship between the inductor load current ( $i_L$ ) and the voltage across capacitor simplifies if the following component selection holds true:

$$\frac{L}{R_{dcr}} = C_{sen} \cdot R_{sen} \quad (\text{EQ. 18})$$

If [Equation 18](#) hold true, the numerator and denominator of the fraction in [Equation 17](#) cancels reducing the voltage across the capacitor to the equation represented in [Equation 19](#).

$$V_c = R_{dcr} \cdot i_L \quad (\text{EQ. 19})$$

Most inductor datasheets will specify the average value of the  $R_{dcr}$  for the inductor.  $R_{dcr}$  values are usually sub 1mΩ with a tolerance averaging 8%. Common chip capacitor tolerances average to 10%.

Inductors are constructed out of metal. Metal has a high temperature coefficient. The temperature drift of the inductor value could cause the DCR circuit to be untuned. An untuned circuit results in inaccurate current measurements along with a chop signal bleeding into the measurement. To counter the temperature variance, a temperature sensor may be incorporated into the design to track the change in component values.

A DCR circuit is good for gross current measurements. As discussed, inductors and capacitors have high tolerances and are temperature dependent which will result in less than accurate current measurements.

In [Figure 41](#), there is a resistor in series with the ISL28022 negative shunt terminal, VINM, with the value of  $R_{sen} + R_{dcr}$ . The resistor's purpose is to counter the effects of the bias current from creating a voltage offset at the input of the ADC.

## Layout

The layout of a current measuring system is equally important as choosing the correct sense resistor and the correct analog converter. Poor layout techniques can result in severed traces, signal path oscillations, magnetic contamination, which all contribute to poor system performance.

## TRACE WIDTH

Matching the current carrying density of a copper trace with the maximum current that will pass through is critical in the performance of the system. Neglecting the current carrying capability of a trace will result in a large temperature rise in the trace and the loss in system efficiency due to the increase in resistance of the copper trace. In extreme cases, the copper

trace could be severed because the trace could not pass the current. The current carrying capability of a trace is calculated using [Equation 20](#):

$$\text{Trace width} = \frac{\left( \frac{I_{\max}}{k \cdot \Delta T} \right)^{0.725}}{\text{Trace Thickness}} \quad (\text{EQ. 20})$$

$I_{\max}$  is the largest current expected to pass through the trace.  $\Delta T$  is the allowable temperature rise in Celsius when the maximum current passes through the trace.  $\text{Trace}_{\text{Thickness}}$  is the thickness of the trace specified to the PCB fabricator in mils. A typical thickness for general current carrying applications (<100mA) is 0.5oz copper or 0.7mils. For larger currents, the trace thickness should be greater than 1.0oz or 1.4mils. A balance between thickness, width and cost needs to be achieved for each design. The coefficient  $k$  in [Equation 20](#) changes depending on the trace location. For external traces, the value of  $k$  equals 0.048 while for internal traces the value of  $k$  reduces to 0.024. The  $k$  values and [Equation 20](#) are stated per the ANSI IPC-2221(A) standards.

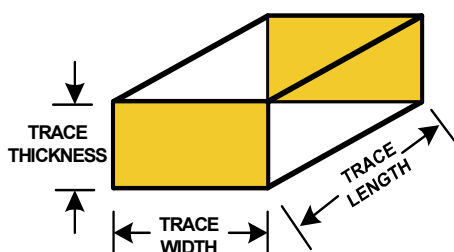
## TRACE ROUTING

It is always advised to make the distance between voltage source, sense resistor and load as close as possible. The longer the trace length between components will result in voltage drops between components. The additional resistance will reduce the efficiency of a system.

The bulk resistance,  $\rho$ , of copper is  $0.67\mu\Omega/\text{in}$  or  $1.7\mu\Omega/\text{cm}$  at  $+25^\circ\text{C}$ . The resistance of trace can be calculated from [Equation 21](#):

$$R_{\text{trace}} = \rho \cdot \frac{\text{Trace length}}{\text{Trace width} \cdot \text{Trace thickness}} \quad (\text{EQ. 21})$$

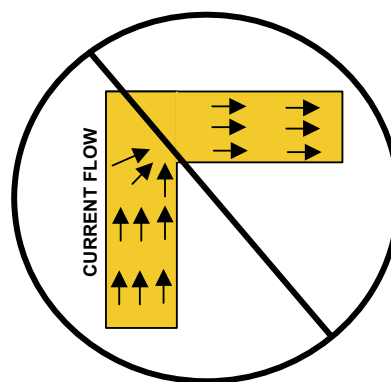
[Figure 42](#) illustrates each dimension of a trace.



**FIGURE 42. ILLUSTRATION OF THE TRACE DIMENSIONS FOR A STRIP LINE TRACE**

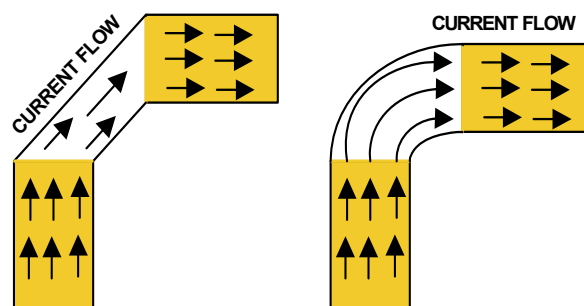
For example, assume a trace has 2oz of copper or 2.8mil thickness, a width of 100mil and a length of 0.5in. Using [Equation 21](#), the resistance of the trace is approximately  $2\text{m}\Omega$ . Assume  $1\text{A}$  of current is passing through the trace. A  $2\text{mV}$  voltage drop would result from trace routing.

Current flowing through a conductor will take the path of least resistance. When routing a trace, avoid orthogonal connections for current bearing traces.



**FIGURE 43. AVOID ROUTING ORTHOGONAL CONNECTIONS FOR TRACES THAT HAVE HIGH CURRENT FLOWS**

Orthogonal routing for high current flow traces will result in current crowding, localized heating of the trace and a change in trace resistance (see [Figure 43](#)).



**FIGURE 44. USE ARCS AND 45 DEGREE TRACES TO SAFELY ROUTE TRACES WITH LARGE CURRENT FLOWS**

The utilization of arcs and  $45^\circ$  traces in routing large current flow traces will maintain uniform current flow throughout the trace. [Figure 44](#) illustrates the routing technique.

## CONNECTING SENSE TRACES TO THE CURRENT SENSE RESISTOR

Ideally, a 4 terminal current sense resistor would be used as the sensing element. Four terminal sensor resistors can be hard to find in specific values and in sizes. Often a two terminal sense resistor is designed into the application.

Sense lines are high impedance by definition. The connection point of a high impedance line reflects the voltage at the intersection of a current bearing trace and a high impedance trace. The high impedance trace should connect at the intersection where the sense resistor meets the landing pad on the PCB. The best place to make current sense line connection is on the inner side of the sense resistor footprint. The illustration of the connection is shown in [Figure 45 on page 28](#). Most of the current flow is at the outer edge of the footprint. The current ceases at the point the sense resistor connects to the landing pad. Assume the sense resistor connects at the middle of the each landing pad, this leaves the inner half of the each landing pad with little current flow. With little current flow, the inner half of each landing pad is classified as high impedance and perfect for a sense connection.

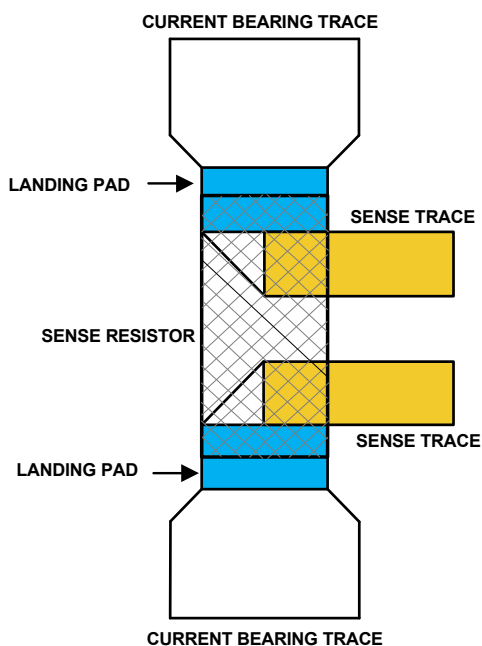
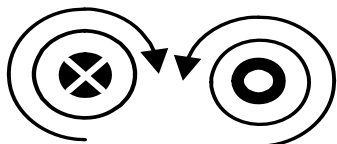


FIGURE 45. CONNECTING THE SENSE LINES TO A CURRENT SENSE RESISTOR

Current sense resistors are often smaller than the width of the traces that connect to the footprint. The trace connecting to the footprint is tapered at a 45° angle to control the uniformity of the current flow.

### MAGNETIC INTERFERENCE

The magnetic field generated from a trace is directly proportional to the current passing through the trace and the distance from the trace the field is being measured at. Figure 46 illustrates the direction the magnetic field flows versus current flow.



$$B = \frac{\mu_0 \cdot I}{2 \cdot \pi \cdot r}$$

FIGURE 46. THE CONDUCTOR ON THE LEFT SHOWS THE MAGNETIC FIELD FLOWING IN A CLOCKWISE DIRECTION FOR CURRENTS FLOWING INTO THE PAGE. A CURRENT FLOW OUT OF THE PAGE HAS A COUNTER CLOCKWISE MAGNETIC FLOW

The equation in Figure 46 determines the magnetic field, B, the trace generates in relation to the current passing through the trace, I, and the distance the magnetic field is being measured from the conductor, r. The permeability of air,  $\mu_0$ , is  $4\pi \cdot 10^{-7}$  H/m.

When routing high-current traces, avoid routing high impedance traces in parallel with high-current bearing traces. A means of limiting the magnetic interference from high-current traces is to closely route the paths connected to and from the sense resistor. The magnetic fields will cancel outside the two traces and add between the two traces. Figure 47 illustrates a layout that is less sensitive to magnetic field interference.

If possible, do not cross traces with high-current. If a trace crossing cannot be avoided, cross the trace in an orthogonal manner and the furthest layer from the current bearing trace. The interference from the current bearing trace will be limited.

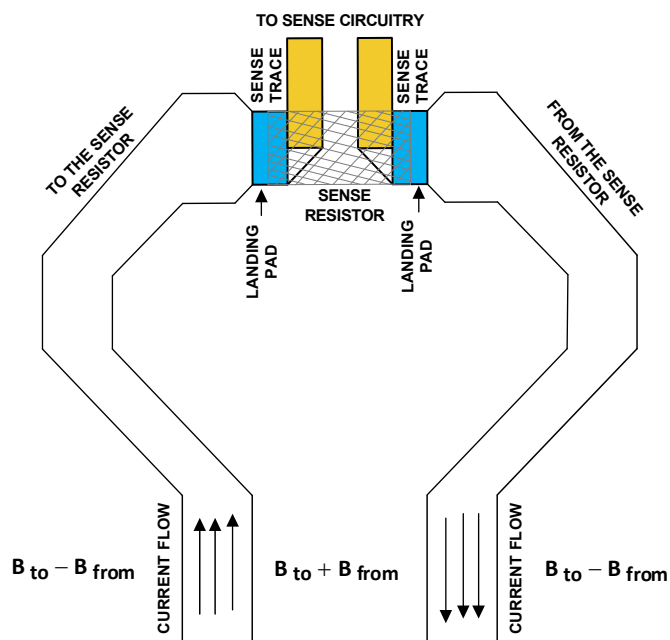


FIGURE 47. CLOSELY ROUTED TRACES THAT CONNECT TO THE SENSE RESISTOR REDUCES THE MAGNETIC INTERFERENCE SOURCED FROM THE CURRENT FLOWING THROUGH THE TRACES

### A Trace as a Sense Resistor

In previous sections, the resistance and the current carrying capabilities of a trace were discussed. In high current sense applications, a design may utilize the resistivity of a current sense trace as the sense resistor. This section will discuss how to design a sense resistor from a copper trace.

Suppose an application needs to measure current up to 200A. The design requires the least amount of voltage drop for maximum efficiency. The full-scale voltage range of 40mV (PGA 00) is chosen. From Ohms law, the sense resistor is calculated to be  $200\mu\Omega$ . The power rating of the resistor is calculated to be 8W. Assume the PCB trace thickness of the board equals 2oz/2.8mils and the maximum temperature rise of the trace is 20°C. Using Equation 20 on page 27, the calculated trace width is 2.192in. The trace width, thickness and the desired sense resistor value is known. Utilizing Equation 21 on page 27, the trace length is calculated to be 1.832in.

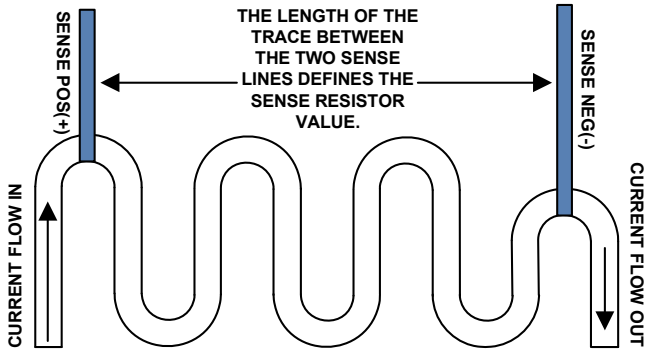


FIGURE 48. ILLUSTRATES A LAYOUT EXAMPLE OF A CURRENT SENSE RESISTOR MADE FROM A PCB TRACE

Figure 48 illustrates a layout example of a current sense resistor defined by a PCB trace. The serpentine pattern of the resistor reduces current crowding as well as limiting the magnetic interference caused by the current flowing through the trace.

The width of the trace in Figure 48 illustration would equal 2.192in and the length between the sense lines equals 1.832in.

The width of the resistor is long for some applications. A means of shortening the trace width is to connect two traces in parallel. For calculation ease, assume the resistive traces are routed on the outside layers of a PCB. Using Equations 20 and 21 on page 27, the width of the trace is reduced from 2.192in to 1.096in.

When using multiple layers to create a trace resistor, use multiple vias to keep the trace potentials between the two conductors the same. Vias are highly resistive compared to a copper trace. Multiple vias should be employed to lower the voltage drop due to current flowing through resistive vias. Figure 49 illustrates a layout technique for a multiple layered trace sense resistor.

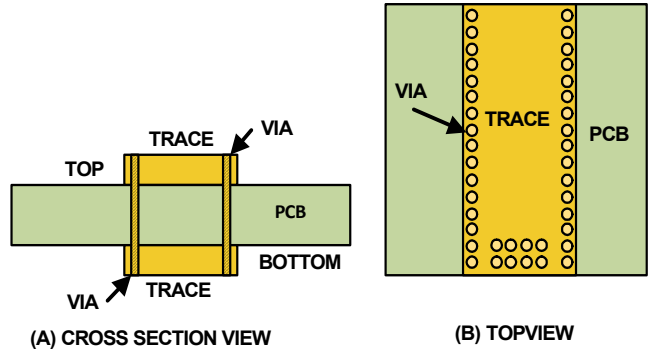


FIGURE 49. ILLUSTRATES A LAYOUT EXAMPLE OF A MULTIPLE LAYER TRACE RESISTOR

## Revision History

The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please go to the web to make sure that you have the latest revision.

| DATE              | REVISION | CHANGE   |
|-------------------|----------|--|
| February 4, 2016  | FN8386.8 | Changed the Polarity of the CNVR bit from High to Low when the ADC is making a conversion. See section "CNVR: Conversion Ready (Bit 1)" on page 17<br>Changed in "Write Operation" on page 22 the description of the first byte of data sent to the ISL28022 from LSB to MSB. The second byte of data was changed from MSB to LSB.<br>In Figure 32 on page 22, added an ACK to the diagram before the repeat start.  |
| October 2, 2015   | FN8386.7 | Changed in Table 15 on page 16, Bit D0 from "FS0" to "0".<br>Added statement in number 3 (second to the last sentence of "Calibration Register 05h (Read/Write)" on page 17, which reads "The calibration value..."  |
| June 17, 2015     | FN8386.6 | Added Related Literature section on page 1.<br>Added DPM Portfolio Comparison table on page 5.<br>Removed Typical Applications section and made into an application note (AN1955).   |
| February 20, 2015 | FN8386.5 | Electrical Specifications table on page 7- DC accuracy under Test Conditions: Updated VSENSE from $\pm 300\text{mV}$ to $\pm 320\text{mV}$ .<br>Table 5 on page 14: Changed in range (mV) column from $\pm 300$ to $\pm 320$ .<br>Table 8 on page 16 updated "FULL-SCALE in title from $\pm 300\text{mV}$ to $\pm 320\text{mV}$ .<br>Equation 1 on page 17: Changed $n=0$ to $n=2$ .<br>Calibration Register 05h (Read/Write) section on page 17 above equation 2, changed range: (300mV, 160mV, 80mV and 40mV) to (320mV, 160mV, 80mV and 40mV).<br>Over-ranging section on page 24: Updated maximum set range from (300mV) to (320mV).<br>Table 22 on page 24 changed PG11 from 300mV to 320mV.<br>Point Of Load Power Monitor section on page 29: Changed shunt voltage from 300mV to 320mV.<br>Equation 22 on page 28: Changed value from 0.30 to 0.32.<br>page 31 updated $V_{\text{shunt}}$ range from 300mV to 320mV. |
| June 9, 2014      | FN8386.4 | Equation 17 on page 26 added $I_L$ before $= R_{\text{dcr}}$<br>Figure 42 on page 27 changed "Of a Strip" to "For a Strip"<br>Figure 47 on page 28 changed "Current flow" to "A current flow"<br>Last sentence in paragraph following Figure 46 on page 28 and second sentence in paragraph under Equation 28 on page 32 changed " $10^7$ " to " $10^{-7}$ "   |
| April 17, 2014    | FN8386.3 | Text revisions done in section "Signal Integrity" on page 23.<br>Added section "Lossless Current Sensing (DCR)" on page 26 and "Monitoring MultiCell Battery Levels Using the ISL28022 Broadcast Command" on page 36.<br>Updated the Ordering Information on page 3 by removing R-spec parts.  |
| October 10, 2013  | FN8386.2 | Added sections from "Shunt Resistor Selection" on page 24 to "An Efficiency Measurement Using the ISL28022 Broadcast Feature" on page 35.  |
| April 26, 2013    | FN8386.1 | Added R-spec parts to ordering information and updated verbiage in About Intersil.   |
| April 16, 2013    | FN8386.0 | Initial Release  |

## About Intersil

Intersil Corporation is a leading provider of innovative power management and precision analog solutions. The company's products address some of the largest markets within the industrial and infrastructure, mobile computing and high-end consumer markets.

For the most updated datasheet, application notes, related documentation and related parts, please see the respective product information page found at [www.intersil.com](http://www.intersil.com).

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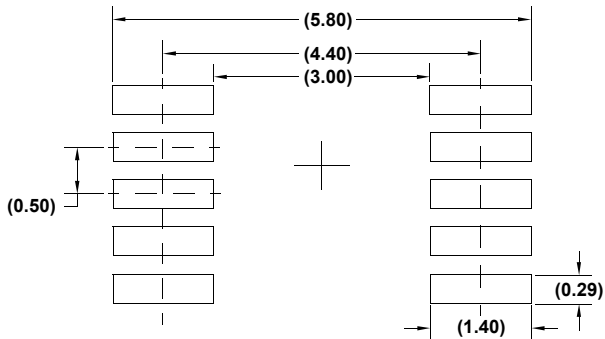
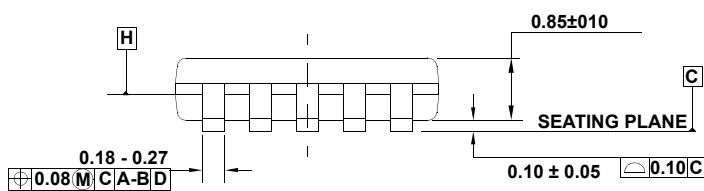
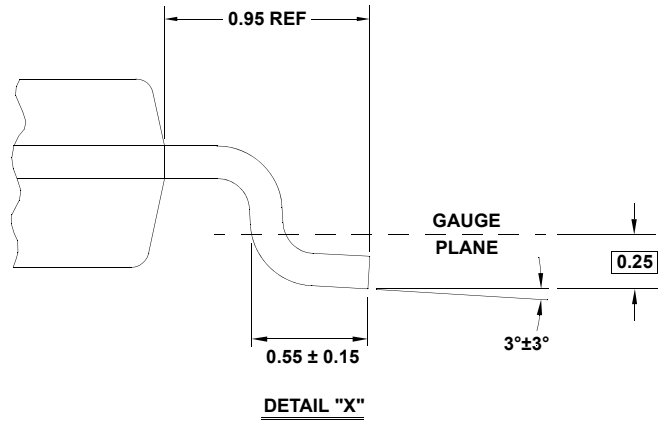
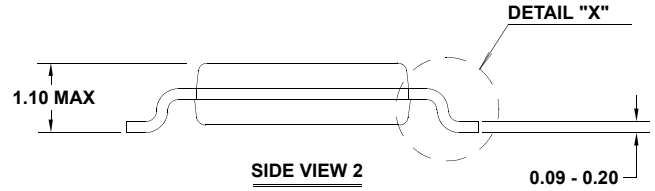
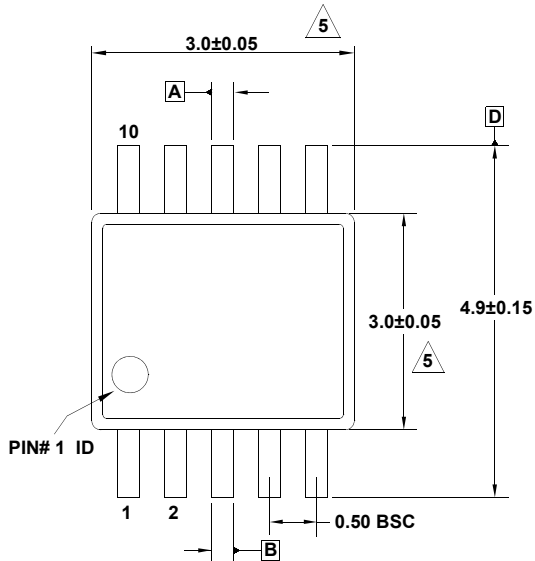
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# Package Outline Drawing

## M10.118

10 LEAD MINI SMALL OUTLINE PLASTIC PACKAGE

Rev 1, 4/12



NOTES:

1. Dimensions are in millimeters.
2. Dimensioning and tolerancing conform to JEDEC MO-187-BA and AMSEY14.5m-1994.
3. Plastic or metal protrusions of 0.15mm max per side are not included.
4. Plastic interlead protrusions of 0.15mm max per side are not included.
5. Dimensions are measured at Datum Plane "H".
6. Dimensions in ( ) are for reference only.

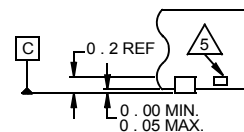
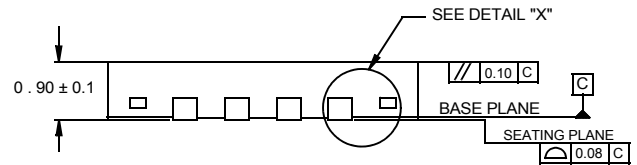
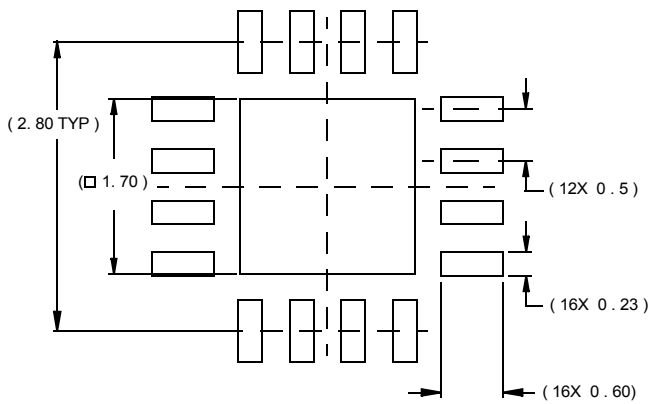
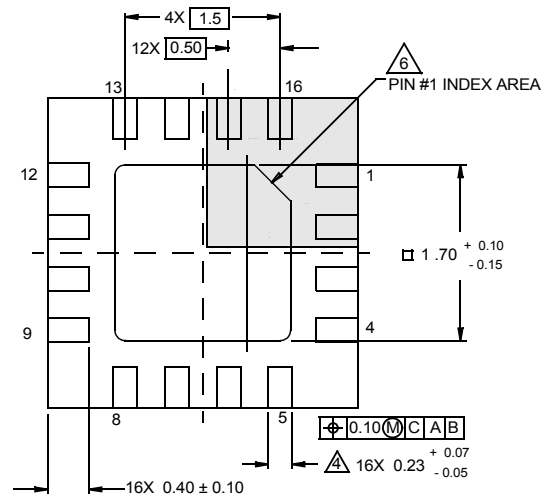
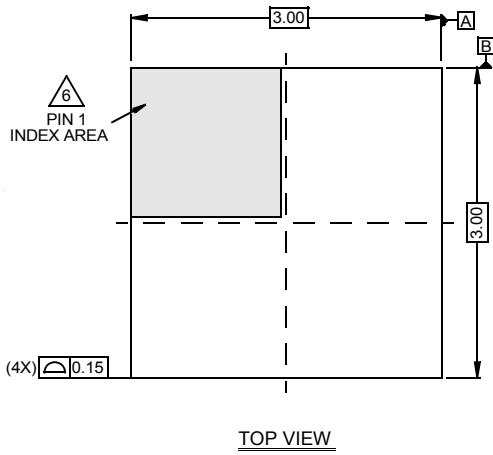


# Package Outline Drawing

## L16.3x3B

16 LEAD QUAD FLAT NO-LEAD PLASTIC PACKAGE

Rev 1, 4/07



NOTES:

- Dimensions are in millimeters.  
Dimensions in ( ) for Reference Only.
- Dimensioning and tolerancing conform to AMSE Y14.5m-1994.
- Unless otherwise specified, tolerance : Decimal  $\pm 0.05$
- Dimension b applies to the metallized terminal and is measured between 0.15mm and 0.30mm from the terminal tip.
- Tiebar shown (if present) is a non-functional feature.
- The configuration of the pin #1 identifier is optional, but must be located within the zone indicated. The pin #1 identifier may be either a mold or mark feature.



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